

GENERAL DESCRIPTION

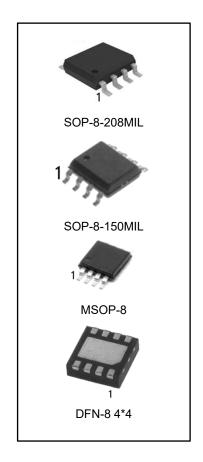
The HG25Q16B of non-volatile flash memory device supports the standard Serial Peripheral Interface (SPI). Traditional SPI single bit serial input and output (Single I/O or SIO) is supported as well as optional two bit (Dual I/O or DIO) and four bit (quad I/O) serial protocols. This multiple width interface is called SPI Multi-I/O or MIO.

The SPI protocols use only 4 to 6 signals:

- Chip Select (CS#)
- Serial Clock (CLK)
- Serial Data
 - IO0 (DI)
 - IO1 (DO)
 - IO2 (WP#)
 - IO3 (HOLD#)

The HG25Q16B support the standard Serial Peripheral Interface (SPI), Dual/Quad I/O SPI: Serial Clock, Chip Select, Serial Data I/O0 (DI), I/O1 (DO), I/O2 (WP#), and I/O3 (HOLD#). The clock frequencies are supported allowing equivalent clock rates of 266MHz (133MHz x 2) for Dual I/O and 532MHz (133MHz x 4) for Quad I/O when using the Fast Read Dual/Quad I/O. These transfer rates can outperform standard synchronous 8 and 16-bit Parallel Flash memories.

A Hold pin, Write Protect pin and programmable write protection, with top or bottom array control, provide further control flexibility. Additionally, the device supports JEDEC standard manufacturer and device ID and SFDP Register, a 128-bit Unique Serial Number and three 256-bytes Security Registers.



The HG25Q16B provides an ideal storage solution for systems with limited space, signal connections, and power. These memories' flexibility and performance is better than ordinary serial flash devices. They are ideal for code shadowing to RAM, executing code directly (XIP), and storing reprogrammable data.

ORDERING INFORMATION

DEVICE	Package Type	MARKING	Packing	Packing Qty
HG25Q16BM/TR	SOP-8-150MIL	25Q16B	REEL	2500pcs/reel
HG25Q16BMW/TR	SOP-8-208MIL	25Q16B	REEL	2500pcs/reel
HG25Q16BMM/TR	MSOP-8	25Q16B	REEL	3000pcs/reel
HG25Q16BDQ/TR	DFN-8	25Q16B	REEL	2500pcs/reel



FEATURES

Low power supply operation

-Single 2.7V-3.6V supply

• 16M bit Serial Flash

- -16 M-bit/2048K-byte/8,192 pages
- -256 bytes per programmable page
- -Uniform 4K-byte Sectors, 32K/64K-byte Blocks

New Family of SpiFlash Memories

- -Standard SPI: CLK, CS#, DI, DO, WP#, HOLD#
- -Dual SPI: CLK, CS#, DI, DO, WP#, HOLD#
- -Quad SPI: CLK, CS#, IO0, IO1, IO2, IO3
- -Software Reset
- -Auto-increment Read capability

Temperature Ranges

-Industrial (-40°C to 105°C)

• Low power consumption

- 10 uA typical standby current
- 1 uA typical power down current

• Efficient "Continuous Read" and Quad Read

- -Continuous Read with 8/16/32/64-Byte Wrap
- -Quad Peripheral Interface reduces instruction overhead

• Flexible Architecture with 4KB sectors

- -Sector Erase (4K-bytes)
- -Block Erase (32K/64K-bytes)
- -Page Program up to 256 bytes

Endurance and Data Retention

- -More than 100K erase/program cycles
- -More than 20-year data retention

Advanced Security Feature

- -Software and Hardware Write-Protect
- -Power Supply Lock-Down and OTP protection
- -Top/Bottom, Complement array protection
- -128-Bit Unique ID for each device
- -Discoverable parameters(SFDP) register
- -3X256-Byte Security Registers with OTP locks
- -Volatile & Non-volatile Status Register Bits

• High performance program/erase speed

- -Page program time: 250us typical
- -Sector erase time: 45ms typical
- -Block erase time: 150ms typical
- -Chip erase time: 3s typical

Package Options

- -SOP8 150mil/208mil
- -MSOP-8
- -DFN8 (2*3*0.55mm)
- -All Pb-free packages are RoHS compliant



BLOCK DIAGRAM

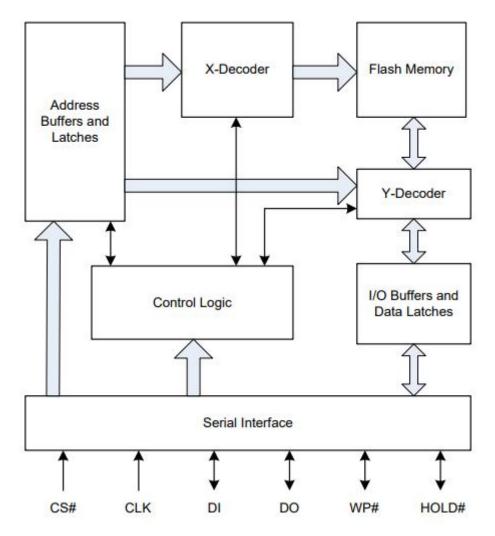


Figure 1 Block Diagram



CONNECTION DIAGRAMS

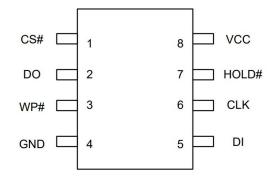


Figure 2 SOP-8 (150/208mil)/MSOP-8/DFN-8

SIGNAL DESCRIPTIONS

Table 1 Pin Descriptions

Symbol	Pin Name
CLK	Serial Clock Input
DI(IO0)	Serial Data Input(Data input output 0) (1)
DO(IO1)	Serial Data Output(Data input output 1) (1)
CS#	Chip Enable
WP#(IO2) ⁽³⁾	Write Protect (Data input output 2) (2)
HOLD# ⁽³⁾ (IO3)	Hold input(Data input output 3) (2)
Vcc	Power Supply (2.7-3.6V)
GND	Ground

Notes:

- (1)IO0 and IO1 are used for Standard and Dual SPI instructions.
- (2)IO0—IO3 are used for QUAD SPI instructions.
- (3)WP# and HOLD# functions are only available for Standard and Dual SPI.

Serial Data Input (DI) / IO0

The SPI Serial Data Input (DI) pin is used to transfer data serially into the device. It receives instructions, address and data to be programmed. Data is latched on the rising edge of the Serial Clock (CLK) input pin. The DI pin becomes IO0 - an input and output during Dual and Quad commands for receiving instructions, address, and data to be programmed (values latched on rising edge of serial CLK clock signal) as well as shifting out data (on the falling edge of CLK).

Serial Data Output (DO) / IO1

The SPI Serial Data Output (DO) pin is used to transfer data serially out of the device. Data is shifted out on the falling edge of the Serial Clock (CLK) input pin. DO becomes IO1 - an input and output during Dual and Quad commands for receiving instructions, addresses, and data to be programmed (values latched on rising edge of serial CLK clock signal) as well as shifting out data (on the falling edge of CLK).



Serial Clock (CLK)

The SPI Serial Clock Input (CLK) pin provides the timing for serial input and output operations. ("See SPI Mode")

Chip Select (CS#)

The SPI Chip Select (CS#) pin enables and disables device operation. When CS# is high the device is deselected and the Serial Data Output pins are at high impedance.

When deselected, the devices power consumption will be at standby levels unless an internal erase, program or status register cycle is in progress. When CS# is brought low the device will be selected, power consumption will increase to active levels and instructions can be written to and data read from the device. After power-up, CS# must transition from high to low before a new instruction will be accepted.

Write Protect (WP#) / IO2

The Write Protect (WP#) pin can be used to prevent the Status Register from being written. Used in conjunction with the Status Register's Block Protect (BP0, BP1 and BP2, TB, SEC, CMP) bits and Status Register Protect (SRP) bits, a portion or the entire memory array can be hardware protected.

The WP# function is not available when the Quad mode is enabled. The WP# function is replaced by IO2 for input and output during Quad mode for receiving addresses and data to be programmed (values are latched on rising edge of the CLK signal) as well as shifting out data (on the falling edge of CLK).

HOLD (HOLD#) / IO3

The HOLD# pin allows the device to be paused while it is actively selected. When HOLD# is brought low, while CS# is low, the DO pin will be at high impedance and signals on the DI and CLK pins will be ignored (don't care). When HOLD# is brought high, device operation can resume. The HOLD# function can be useful when multiple devices are sharing the same SPI signals. The HOLD# pin is active low. When the QE bit of Status Register-2 is set for Quad I/O, the HOLD# pin function is not available since this pin is used for IO3.



MEMORY ORGANIZATION

Flash Memory Array

The HG25Q16B memory is organized as:

- 2,097,152bytes
- Uniform Sector Architecture 32 blocks of 64-Kbyte
- 512 sectors of 4-Kbyte
- 8, 192 pages (256 bytes each)

Each page can be individually programmed (bits are programmed from 1 to 0). The device is Sector, Block or Chip Erasable but not Page Erasable.

Table 2⁽¹⁾ Memory Organization(HG25Q16B)

Block/ Security Register/SFDP	Sector	Address range		
Security Register 3	-	003000H	0030FFH	
Security Register 2	-	002000H	0020FFH	
Security Register 1	-	001000H	0010FFH	
Security Register 0 (SFDP)	-	000000Н	0000FFH	
	511	1FF000H	1FFFFFH	
Block 31				
	496	1F0000H	1F0FFFH	
	495	1EF000H	1EFFFFH	
Block 30				
	480	1E0000H	1E0FFFH	
	47	02F000H	02FFFFH	
Block 2				
	32	020000H	020FFFH	
	31	01F000H	01FFFFH	
Block 1				
	16	010000H	010FFFH	
	15	00F000H	00FFFFH	
Block 0				
	0	000000H	000FFFH	

Notes:

(1) These are condensed tables that use a couple of sectors as references. There are address ranges that are not explicitly listed. All 4-kB sectors have the pattern XXX000h-XXXFFFh.



Security Registers

The HG25Q16B provides four 256-byte Security Registers. Each register can be used to store information that can be permanently protected by programming One Time Programmable (OTP) lock bits in Status Register-2.

Register 0 is used by FSRK to store and protect the Serial Flash Discoverable Parameters (SFDP) information that is also accessed by the Read SFDP command. See Table 2.

The three additional Security Registers can be erased, programmed, and protected individually. These registers may be used by system manufacturers to store and permanently protect security or other important information separate from the main memory array.

Security Register 0

Serial Flash Discoverable Parameters (SFDP — JEDEC JESD216D):

This document defines the Serial Flash Discoverable Parameters (SFDP) revision D data structure for HG25Q16B family.

The Read SFDP (RSFDP) command (5Ah) reads information from a separate flash memory address space for device identification, feature, and configuration information, in accord with the JEDEC JESD216D standard for Serial Flash Discoverable Parameters.

The SFDP data structure consists of a header table that identifies the revision of the JESD216 header format that is supported and provides a revision number and pointer for each of the SFDP parameter tables that are provided. The parameter tables follow the SFDP header. However, the parameter tables may be placed in any physical location and order within the SFDP address space. The tables are not necessarily adjacent nor in the same order as their header table entries.

The SFDP header points to the following parameter tables:

Basic Flash

- This is the original SFDP table.

The physical order of the tables in the SFDP address space is: SFDP Header, and Basic Flash. The SFDP address space is programmed by ZBIT and read-only for the host system.

Serial Flash Discoverable Parameters (SFDP) Address Map

The SFDP address space has a header starting at address zero that identifies the SFDP data structure and provides a pointer to each parameter. One Basic Flash parameter is mandated by the JEDEC JESD216D standard.

Table 3 SFDP Overview Map — Security Register 0
 Description

Byte Address	Description		
0000h	Location zero within JEDEC JESD216D SFDP space – start of SFDP header		
0020h	Undefined space reserved for future SFDP header		
0030h	Start of SFDP parameter		
	Remainder of SFDP JEDEC parameter followed by undefined space		
007Bh	End of SFDP space		
007Ch to 00FFh	Reserved space		



SFDP Header Field Definitions

Table 4 SFDP Signature and Parameter Identification Data Value

SFDP Byte Address	SFDP Dword Name	Data	Description
00h	050011 1 4 1	53h	This is the entry point for Read SFDP (5Ah) command i.e. location zero within SFDP space ASCII "S"
01h	SFDP Header 1st DWORD	46h	ASCII "F"
02h	DWORD	44h	ASCII "D"
03h		50h	ASCII "P"
04h		08h	SFDP Minor Revision Number This 8-bit field indicates the minor revision number of this standard. The value in this field is 08h for devices which implement the JESD216D revision
05h	SFDP Header 2nd DWORD	01h	SFDP Major Revision Number This 8-bit field indicates the major revision number of this standard. The value in this field is 01h for devices which implement the JESD216D revision
06h		01h	Number of Parameter Headers (zero based, 00h = 1 parameters)
07h		FFh	SFDP Access Protocol field
08h		00h	Parameter ID LSB The JEDEC Basic Flash Parameter Table is assigned the ID LSB of 00h.
09h	Parameter Header 0 1st DWORD	07h	Parameter Table Minor Revision Number This 8-bit field indicates the minor revision number of the JEDEC Basic Flash Parameter table. The value in this field is 07h for this table defined by JESD216D revision
0Ah		01h	Parameter Table Major Revision Number This 8-bit field indicates the major revision number of the parameter table. The value in this field is 01h for this table defined by JESD216D revision
0Bh		10h	Parameter Table Length (in double words = Dwords = 4-byte units) 10h = 16 Dwords
0Ch		30h	Parameter Table Pointer Byte 0 (Dword = 4-byte aligned) JEDEC Basic SPI Flash parameter byte offset = 30h
0Dh	Parameter Header 0	00h	Parameter Table Pointer Byte 1
0Eh	2nd DWORD	00h	Parameter Table Pointer Byte 2
0Fh		FFh	Parameter ID MSB (FFh = JEDEC defined legacy Parameter ID)
10h		5Eh	ID NumberIt indicates ZBIT manufacture ID
11h	Parameter Header 1 1st DWORD	00h	Parameter Table Minor Revision Number Starts from 00h
12h	ISL DAYOND	01h	Parameter Table Major Revision Number Starts from 01h
13h		03h	Parameter Table Length, 0 based
14h	Parameter Header 1 2nd DWORD	70h	Parameter Table Pointer Byte 0 (Dword = 4-byte aligned) ZBIT Flash parameter byte offset = 70h
15h		00h	Parameter Table Pointer Byte 1
16h		00h	Parameter Table Pointer Byte 2
17h		FFh	Unused



JEDEC SFDP Basic SPI Flash Parameter

Table 5 Basic SPI Flash Parameter, JEDEC SFDP Rev D (Sheet 1 of 5)

	Table 3 E	Jasic OF I FIdSI	h Parameter, JEDEC SFDP Rev D (Sheet 1 of 5)
SFDP Parameter Relative Byte Address	SFDP Dword Name	Data	Description
30h		E5h	Start of SFDP JEDEC parameter Bits 7:5 = unused = 111b Bit 4:3 = 05h is volatile status register write instruction and status register is default non-volatile= 00b Bit 2 = Program Buffer > 64 bytes = 1 Bits 1:0 = Uniform 4-kB erase is supported throughout the device = 01b
31h		20h	Bits 15:8 = Uniform 4-kB erase instruction = 20h
32h	JEDEC Basic Flash Parameter Dword-1	F1h	Bit 23 = Unused = 1b Bit 22 = Supports QOR Read (1-1-4), Yes = 1b Bit 21 = Supports QIO Read (1-4-4), Yes = 1b Bit 20 = Supports DIO Read (1-2-2), Yes = 1b Bit 19 = Supports DTR, No= 0 b Bit 18:17 = Number of Address Bytes 3 only = 00b Bit 16 = Supports SIO and DIO Yes = 1b Binary Field: 1-1-1-1-0-00-1 Nibble Format: 1111_0001 Hex Format: F1
33h		FFh	Bits 31:24 = Unused = FFh
34h	JEDEC	FFh	Density in bits, zero based,
35h	Basic Flash	FFh	4 Mb = 003FFFFFh
36h	Parameter	FFh	8 Mb = 007FFFFFh
37h	Dword-2	00h	16 Mb = 00FFFFFh
38h	JEDEC	44h	Bits 7:5 = number of QIO (1-4-4)Mode cycles = 010b Bits 4:0 = number of Fast Read QIO Dummy cycles = 00100b for default latency code
39h	Basic Flash Parameter	EBh	Fast Read QIO (1-4-4)instruction code
3Ah	Dword-3	08h	Bits 23:21 = number of Quad Out (1-1-4) Mode cycles = 000b Bits 20:16 = number of Quad Out Dummy cycles = 01000b for default latency code
3Bh		6Bh	Quad Out (1-1-4)instruction code
3Ch	JEDEC	08h	Bits 7:5 = number of Dual Out (1-1-2)Mode cycles = 000b Bits 4:0 = number of Dual Out Dummy cycles = 01000b for default latency code
3Dh	Basic Flash	3Bh	Dual Out (1-1-2) instruction code
3Eh	Parameter Dword-4	80h	Bits 23:21 = number of Dual I/O Mode cycles = 100b Bits 20:16 = number of Dual I/O Dummy cycles = 00000b for default latency code
3Fh		BBh	Dual I/O instruction code
40h	JEDEC Basic Flash	EEh	Bits 7:5 RFU = 111b Bit 4 = QPI (4-4-4) fast read commands not supported = 0b , Bits 3:1 RFU = 111b Bit 0 = Dual All not supported = 0b
41h	Parameter	FFh	Bits 15:8 = RFU = FFh
42h	Dword-5	FFh	Bits 23:16 = RFU = FFh
43h		FFh	Bits 31:24 = RFU = FFh
44h		FFh	Bits 7:0 = RFU = FFh
45h	JEDEC	FFh	Bits 15:8 = RFU = FFh
46h	Basic Flash Parameter Dword-6	FFh	Bits 23:21 = number of Dual All Mode cycles = 111b Bits 20:16 = number of Dual All Dummy cycles = 11111b
47h	_ Dword-6	FFh	Dual All instruction code
			I .



Table 6 Basic SPI Flash Parameter, JEDEC SFDP Rev D (Sheet 2 of 5)

SFDP Parameter Relative Byte Address	SFDP Dword Name	Data	Description
48h	JEDEC	0Ch	Erase Type 1 size 2 ^N Bytes = 4 kB = 0Ch (for Uniform 4 kB)
49h	Basic Flash	20h	Erase Type 1 instruction
4Ah	Parameter	0Fh	Erase Type 2 size 2 ^N Bytes = 32 kB = 0Fh (for Uniform 32 kB)
4Bh	Dword-8	52h	Erase Type 2 instruction
4Ch	JEDEC	10h	Erase Type 3 size 2 ^N Bytes =64 kB = 10h(for Uniform 64 kB)
4Dh	Basic Flash	D8h	Erase Type 3 instruction
4Eh	Parameter	00h	Erase Type 4 size 2 ^N Bytes = not supported = 00h
4Fh	Dword-9	FFh	Erase Type 4 instruction = not supported = FFh
50h		21h	Bits 31:30 = Erase Type 4 Erase, Typical time units
51h		42h	(00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b:1 s) = RFU = 11b
52h		BDh	Bits 29:25 = Erase Type 4 Erase, Typical time count = RFU = 11111b (typ erase time = (count+1) * units) = RFU =11111
53h	JEDEC Basic Flash Parameter Dword-10	FEh	Bits 24:23 = Erase Type 3 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b:1 s) = RFU = 01b Bits 22:18 = Erase Type 3 Erase, Typical time count = 01111b (typ erase time = (count +1) *units) = 16*16 ms = 250ms Bits 17:16 = Erase Type 2 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b:1 s) = 16 ms = 01b Bits 15:11 = Erase Type 2 Erase, Typical time count = 01000b (typ erase time = (count +1) *units) = 9*16 ms = 150 ms Bits 10:9 = Erase Type 1 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1s) = 16ms = 01b Bits 8:4 = Erase Type 1 Erase, Typical time count = 00010b (typ erase time = (count +1) *units) = 3*16 ms = 45 ms Bits 3:0 = Count = (Max Erase time / (2 * Typical Erase time))- 1 = 0001b Multiplier from typical erase time to maximum erase time = 8x multiplier Max Erase time = 2*(Count +1)*Typ Erase time Binary Fields: 1111111_0101111_010100_010001_0001 Nibble Format: 1111_1110_1011_11010100_0010_0010_0001 Hex Format: FE_BD_42_21



Table 7 Basic SPI Flash Parameter, JEDEC SFDP Rev D (Sheet 3 of 5)

	Table 1	Dasic Ci i	Flash Parameter, JEDEC SFDP Rev D (Sheet 3 01 5)
SFDP			
Parameter	SFDP	Data	Description
Relative Byte	Dword Name	Data	Description
Address			
54h		81h	Bits 23 = Byte Program Typical time, additional byte units (0b:1 μs, 1b:8 μs) = 1 μs = 0b
55h		65h	Bits 22:19 = Byte Program Typical time, additional byte count, (count+1)*units, count =
56h	JEDEC Basic Flash Parameter Dword-11	14h	0010b,(typ Program time = (count +1) * units) = 3*1 μs = 3 μs Bits 18 = Byte Program Typical time, first byte units (0b:1 μs, 1b:8 μs) = 8 μs = 1b Bits 17:14 = Byte Program Typical time, first byte count, (count+1)*units, count = 0001b, (typ Program time = (count +1) * units) = 2*8 μs = 16 μs Bits 13 = Page Program Typical time units (0b:8 μs, 1b:64 μs) = 64 μs = 1b Bits 12:8 = Page Program Typical time count, (count+1)*units, count = 00101b, (typ Program time = (count +1) * units) = 6*64 μs = 400 μs Bits 7:4 = N = 1000b, Page size= 2N = 256B page Bits 3:0 = Count = 0001b = (Max Page Program time / (2 * Typ Page Program time))- 1 Multiplier from typical Page Program time to maximum Page Program time = 4x multiplier Max Page Program time = 2*(Count +1)*Typ Page Program time Binary Fields: 0-0010-1-0001-1-00101-1000-0001 Nibble Format: 0001_0100_0110_0101_1000_0001 Hex Format: 14_65_81
57h		C1h	16 Mb = 1100_0001b = C1h Bit 31 Reserved = 1b Bits 30:29 = Chip Erase, Typical time units (00b: 16 ms, 01b: 256 ms, 10b: 4 s, 11b: 64 s) = 4s= 10b Bits 28:24 = Chip Erase, Typical time count, (count+1)*units, count = 00001b, (typ Program time = (count +1) * units) = 2*4s = 8s
58h		ECh	Bit 31 = Suspend and Resume supported = 0b
59h		63h	Bits 30:29 = Suspend in-progress erase max latency units (00b: 128ns, 01b: 1us, 10b: 8
5Ah		16h	μs,11b: 64 μs) = 1 μs= 01b
5Bh	JEDEC Basic Flash Parameter Dword-12	33h	Bits 28:24 = Suspend in-progress erase max latency count = 10011b, max erase suspend latency = (count +1) * units = 20*1 μs = 20 μs Bits 23:20 = Erase resume to suspend interval count = 0001b, interval = (count +1) * 64 μs = 2* 64 μs = 128 μs Bits 19:18 = Suspend in-progress program max latency units (00b: 128ns, 01b: 1us, 10b: 8 μs,11b: 64 μs) = 1 μs= 01b Bits 17:13 = Suspend in-progress program max latency count = 10011b, max erase suspend latency = (count +1) * units = 20*1 μs = 20 μs Bits 12:9 = Program resume to suspend interval count = 0001b, interval = (count +1) * 64 μs = 2 * 64 μs = 128 μs Bit 8 = RFU = 1b Bits 7:4 = Prohibited operations during erase suspend = xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) + xx1xb: May not initiate a read in the erase suspended sector size + x1xxb: The erase and program restrictions in bits 5:4 are sufficient = 1110b Bits 3:0 = Prohibited Operations During Program Suspend = xxx0b: May not initiate a new erase anywhere (program nesting not permitted) + x1xxb: May not initiate a new erase anywhere (program nesting not permitted) + x1xxb: May not initiate a new page program anywhere (program nesting not permitted) + x1xxb: May not initiate a read in the program suspended page size + 1xxxb: The erase and program restrictions in bits 1:0 are sufficient = 1100b Binary Fields: 0-01-10011-0001-0110-0110-0111-1110-1100 Nibble Format: 0011_0011_0001_0110_011_10101_1110



Table 8 Basic SPI Flash Parameter, JEDEC SFDP Rev D (Sheet 4 of 5)

SFDP			
Parameter	SFDP		
Relative Byte	Dword	Data	Description
Address	Name		
5Ch	JEDEC	7Ah	Bits 31:24 = Erase Suspend Instruction = 75h
5Dh	Basic Flash	75h	Bits 23:16 = Erase Resume Instruction = 7Ah
5Eh	Parameter	7Ah	Bits 15:8 = Program Suspend Instruction = 75h
5Fh	Dword-13	75h	Bits 7:0 = Program Resume Instruction = 7Ah
60h		F7h	Bit 31 = Deep Power-Down Supported = 0b
61h		A2h	Bits 30:23 = Enter Deep Power-Down Instruction = B9h
62h		D5h	Bits 22:15 = Exit Deep Power-Down Instruction = ABh
			Bits 14:13 = Exit Deep Power-Down to next operation delay units = (00b: 128 ns, 01b: 1
			μ s,10b: 8 μ s, 11b: 64 μ s) = 1 μ s = 01b
	JEDEC		Bits 12:8 = Exit Deep Power-Down to next operation delay count = 00010b, Exit Deep
	Basic Flash		Power-Down to next operation delay = (count+1)*units = 3*1 µs=3 µs
	Parameter		Bits 7:4 = RFU = 1111b
63h	Dword-14	5Ch	Bit 3:2 = Status Register Polling Device Busy
0011		3011	= 01b: Legacy status polling supported = Use legacy polling by reading the Status
			Register with 05h instruction and checking WIP bit[0] (0=ready; 1=busy).
			Bits 1:0 = RFU = 11b
			Binary Fields: 0-10111001-1010111-01-00010-1111-01-11
			Nibble Format: 0101_1100_1101_0101_1010_0010_1111_0111
CAL		401-	Hex Format: 5C_D5_A2_F7
64h		19h	Bits 31:24 = RFU = FFh Bit 23 = Uold and M/B Disable = act OF/bit 1 of SB2) birth = 1b
65h		F6h	Bit 23 = Hold and WP Disable = set QE(bit 1 of SR2) high = 1b Bits 22:20 = Quad Enable Requirements
66h		DDh	= 101b: QE is bit 1 of the status register 2. Status register 1 is read using Read Status
			instruction 05h. Status register 2 is read using instruction 35h. QE is set via Write Status
			instruction 01h with two data bytes where bit 1 of the second byte is one. It is cleared via
			Write Status with two data bytes where bit 1 of the second byte is zero.
			Bits 19:16 0-4-4 Mode Entry Method
			= xxx1b: Mode Bits[7:0] = A5h Note: QE must be set prior to using this mode
			+ x1xxb: Mode Bits[7:0] = Axh
			+ 1xxxb: RFU
			= 1101b
	IEDEC		Bits 15:10 0-4-4 Mode Exit Method
	JEDEC Basic Flash		= xx_xxx1b: Mode Bits[7:0] = 00h will terminate this mode at the end of the current read
	Parameter		operation
67h	Dword-15	FFh	+ xx_1xxxb: Input Fh (mode bit reset) on DQ0-DQ3 for 8 clocks. This will terminate the
67h	DWOIG-10	FFII	mode prior to the next read operation.
			+ 11_x1xx: RFU
			= 111101b
			Bit 9 = 0-4-4 mode supported = 1
			Bits 8:4 = 4-4-4 mode enable sequences = 0_0001b: set QE per QER description above,
			then issue instruction 38h
			Bits 3:0 = 4-4-4 mode disable sequences
			= xxx1b: issue FFh instruction
			+ 1xxxb: issue the Soft Reset 66/99 sequence = 1001b
			- 10015 Binary Fields: 11111111-1-101-1101-111101-1-00001-1001
			Nibble Format: 1111_1111-1101-1101-1111_0110_0001-1001
			Hex Format: FF_DD_F6_19
			TIOX OIIIIGE 1 _ DD_ 0_ 3



Table 9 Basic SPI Flash Parameter, JEDEC SFDP Rev D (Sheet 5 of 5)

SFDP Parameter Relative Byte Address	SFDP Dword Name	Data	Description
68h		E8h	Bits 31:24 = Enter 4-Byte Addressing
69h		30h	= xxxx_xxx1b:issue instruction B7 (preceding write enable not required + xx1x xxxxb: Supports dedicated 4-byte address instruction set. Consult vendor data
6Ah		C0h	sheet
6Bh	JEDEC Basic Flash Parameter Dword-16	80h	for the instruction set definition or look for 4-byte Address Parameter Table. + 1xxx_xxxxb: Reserved = 10000000b not supported Bits 23:14 = Exit 4-byte Addressing = xx_xxxx_xxxtb: bissue instruction E9h to exit 4-byte address mode (Write enable instruction 06h is not required) + xx_xx1x_xxxxb: Software reset + xx_x1xx_xxxxb: Software reset (see bits 13:8 in this DWORD) + xx_1xxx_xxxxb: Reserved + x1_xxxx_xxxxb: Reserved + 11_0000_0000b not supported Bits 13:8 = Soft Reset and Rescue Sequence Support = x1_xxxxb: issue reset enable instruction 66h, then issue reset instruction 99h. The reset enable, reset sequence may be issued on 1,2, or 4 wires depending on the device operating mode + 1x_xxxxb: exit 0-4-4 mode is required prior to other reset sequences above if the device may be operating in this mode. = 11_0000b Bit 7 = RFU = 1 Bits 6:0 = Volatile or Non-Volatile Register and Write Enable Instruction for Status Register 1 = xxx_1xxxb: Non-Volatile/Volatile status register 1 powers-up to last written value in the nonvolatile status register, use instruction 06h to enable write to non-volatile status register. Volatile status register may be activated after power-up to override the non-volatile status register, use instruction 50h to enable write and activate the volatile status register. + x1x_xxxxxb: Reserved + 1xx_xxxxxb: Reserved + 1101000b Binary Fields: 10000000-110000000-110000_0011_0000_1110_1000 Hex Format: 80_C0_30_E8



Table 10 FSRK flash parameter

Parameter Relative Byte Address	OFDD			Table 101 Office last parameter
Title	Relative Byte Address	Dword		
71h	70h		00h	Bits 15:0 = Vcc Supply Maximum Voltage
72h	71h		36h	2700h = 2.700 V
2256h = 2.256V	72h	l .	00h	Bits 31:16 = Vcc Supply Minimum Voltage ,1650h = 1.650V
Bit 1 = HW Hold# pin (0=not support, 1=support) = 1b Bit 2 = Deep Power Down Mode (0=not support, 1=support) = 1b Bit 3 = SW Reset (0=not support, 1=support) = 1b Bit 3 = SW Reset (0=not support, 1=support) = 1b Bit 11:4 = SW Reset (0=not support, 1=support) = 1b Bit 13 = SW Reset (0=not support, 1=support) = 1b Bit 13 = Erase Suspend/Resume (0=not support, 1=support) = 1b Bit 14 = Unused = 1b Bit 15 = Wrap-Around Read mode (0=not support, 1=support) = 1b Bit 15 = Wrap-Around Read mode (0=not support, 1=support) = 1b Bit 15 = Wrap-Around Read mode (0=not support, 1=support) = 1b Bit 15 = Wrap-Around Read mode (0=not support, 1=support) = 1b Bit 15 = Wrap-Around Read mode Opcode Wrap-Around Read data length OBH:support 8B wrap-around read 16H:8B&16B	73h	Dword-1	27h	2350h = 2.350V
Bit 2 = Deep Power Down Mode (0=not support, 1=support) = 1b	74h		9Fh	Bit 0 = HW Reset# pin (0=not support, 1=support) = 0b
FCh Bit 0 = Individual block lock (0=not support, 1=support) = 0b Bit 1 = Individual block lock bit (Volatile/Nonvolatile) (0=Volatile, 1=Nonvolatile) = 0b Bit 1 = Individual block lock Opcode = 11111111b Bit 10 = Individual block lock Volatile protect bit default protect status (0=protect, 1=unprotect) = 0b Bit 11 = Secured OTP (0=not support, 1=support) = 1b Bit 12 = Read Lock (0=not support, 1=support) = 0b Bit 13 = Permanent Lock (0=not support, 1=support) = 0b/1b(1) Bits 15:14 = Unused = 11b Binary Fields: 110(1)010_11111111_00 Nibble Format: 110(1)0_1011_1111_1100 Hex Format: C(E)B_FC TAh FFh Unused	76h	parameter	77h	Bit 2 = Deep Power Down Mode (0=not support, 1=support) = 1b Bit 3 = SW Reset (0=not support, 1=support) = 1b Bits 11:4 = SW Reset Opcode: Should be issue Reset Enable(66H) before Reset cmd = 10011001b Bit 12 = Program Suspend/Resume (0=not support, 1=support) = 1b Bit 13 = Erase Suspend/Resume (0=not support, 1=support) = 1b Bit 14 = Unused = 1b Bit 15 = Wrap-Around Read mode (0=not support, 1=support) = 1b Binary Fields: 0111_10011001_1111 Nibble Format: 0111_1001_1001_1111 Hex Format: 79_9F Wrap-Around Read mode Opcode Wrap-Around Read data length 08H:support 8B wrap-around read 16H:8B&16B 32H:8B&16B&32B
Bit 1 = Individual block lock bit (Volatile/Nonvolatile) (0=Volatile, 1=Nonvolatile) = 0b Bits 9:2 = Individual block lock Opcode = 111111111b Bit 10 = Individual block lock Volatile protect bit default protect status (0=protect, 1=unprotect) = 0b Bit 11 = Secured OTP (0=not support, 1=support) = 1b Bit 12 = Read Lock (0=not support, 1=support) = 0b Bit 13 = Permanent Lock (0=not support, 1=support) = 0b/1b(1) Bits 15:14 = Unused = 11b Binary Fields: 110(1)010_11111111_00 Nibble Format: 110(1)0_1011_1111_1100 Hex Format: C(E)B_FC TAh Bit 1 = Individual block lock bit (Volatile/Nonvolatile) (0=Volatile, 1=Nonvolatile) = 0b Bits 9:2 = Individual block lock Opcode = 11111111b Bit 10 = Individual block lock Opcode = 111111111b Bit 10 = Individual block lock Opcode = 111111111b Bit 10 = Individual block lock Opcode = 11111111111111b Bit 11 = Individual block lock Opcode = 11	70h		F.C.b.	
7Ah FFh Unused		parameter		Bit 1 = Individual block lock bit (Volatile/Nonvolatile) (0=Volatile, 1=Nonvolatile) = 0b Bits 9:2 = Individual block lock Opcode = 11111111b Bit 10 = Individual block lock Volatile protect bit default protect status (0=protect, 1=unprotect) = 0b Bit 11 = Secured OTP (0=not support, 1=support) = 1b Bit 12 = Read Lock (0=not support, 1=support) = 0b Bit 13 = Permanent Lock (0=not support, 1=support) = 0b/1b(1) Bits 15:14 = Unused = 11b Binary Fields: 110(1)010_1111111_00 Nibble Format: 110(1)0_1011_11111_1100
	7Ah	†	FFh	· · =
				Unused

NOTE:

(1) HG25Q16B support Permanent Lock. Please contact hgsemi for details.



FUNCTION DESCRIPTION

SPI Operations

SPI Modes

The HG25Q16B can be driven by an embedded microcontroller (bus master) in either of the two following clocking modes.

- Mode 0 with Clock Polarity (CPOL) = 0 and, Clock Phase (CPHA) = 0
- Mode 3with CPOL = 1 and, CPHA = 1

For these two modes, input data is always latched in on the rising edge of the CLK signal and the output data is always available on the falling edge of the CLK clock signal.

The difference between the two modes is the clock polarity when the bus master is in standby mode and not transferring any data.

- CLK will stay at logic low state with CPOL = 0, CPHA = 0
- CLK will stay at logic high state with CPOL = 1, CPHA = 1

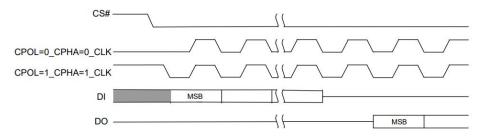


Figure 3 SPI Modes

Timing diagrams throughout the rest of the document are generally shown as both mode 0 and 3 by showing CLK as both high and low at the fall of CS#. In some cases a timing diagram may show only mode 0 with CLK low at the fall of CS#. In such case, mode 3 timing simply means clock is high at the fall of CS# so no CLK rising edge set up or hold time to the falling edge of CS# is needed for mode 3.

CLK cycles are measured (counted) from one falling edge of CLK to the next falling edge of CLK. In mode 0 the beginning of the first CLK cycle in a command is measured from the falling edge of CS# to the first falling edge of CLK because CLK is already low at the beginning of a command.

Dual SPI Modes

The HG25Q16B supports Dual SPI Operation when using the Fast Read Dual Output (3Bh) and Fast Dual I/O (BBh) instruction. These features allow data to be transferred from the device at twice the rate possible with the standard SPI. These instructions are ideal for quickly downloading code to RAM upon Power-up (code-shadowing) or for executing non-speed-critical code directly from the SPI bus (XIP). When using Dual SPI commands, the DI and DO pins become bidirectional I/O pins: IOO and IO1.



Quad SPI Modes

The HG25Q16B supports Quad SPI operation when using the Fast Read Quad Output (6Bh), Fast Read Quad I/O (EBh) instruction. These instructions allow data to be transferred to or from the device four times the rate of ordinary Serial Flash. The Quad Read instructions offer a significant improvement in continuous and random access transfer rates allowing fast code-shadowing to RAM or execution directly from the SPI bus (XIP). When using Quad SPI instructions, the DI and DO pins become bidirectional IO0 and IO1, and the WP# and HOLD# pins become IO2 and IO3 respectively. Quad SPI instructions require the non-volatile Quad Enable bit (QE) in Status Register-2 to be set.

Hold Function

For Standard SPI and Dual SPI operations, the HOLD# (IO3) signal allows the device interface operation to be paused while it is actively selected (when CS# is low). The Hold function may be useful in cases where the SPI data and clock signals are shared with other devices. For example, if the page buffer is only partially written when a priority interrupt requires use of the SPI bus, the Hold function can save the state of the interface and the data in the buffer so programming command can resume where it left off once the bus is available again. The Hold function is only available for standard SPI and Dual SPI operation, not during Quad SPI.

To initiate a Hold condition, the device must be selected with CS# low. A Hold condition will activate on the falling edge of the HOLD# signal if the CLK signal is already low. If the CLK is not already low the Hold condition will activate after the next falling edge of CLK. The Hold condition will terminate on the rising edge of the HOLD# signal if the CLK signal is already low. If the CLK is not already low the Hold condition will terminate after the next falling edge of CLK. During a Hold condition, the Serial Data Output, (DO) or IOO and IO1, are high impedance and Serial Data Input, (DI) or IOO and IO1, and Serial Clock (CLK) are ignored. The Chip Select (CS#) signal should be kept active (low) for the full duration of the Hold operation to avoid resetting the internal logic state of the device.

Software Reset

The HG25Q16B can be reset to the initial power-on state by a software Reset sequence, either in SPI mode. This sequence must include two consecutive commands: Enable Reset (66h) & Reset (99h). If the command sequence is successfully accepted, the device will take approximately 30us (tRST) to reset. No command will be accepted during the reset period.

Status Register

The Read and Write Status Registers commands can be used to provide status and control of the flash memory device.

Status Register-1 (SR1) and Status Register-2 (SR2) can be used to provide status on the availability of the flash memory array, whether the device is write enabled or disabled, the state of write protection, Quad SPI setting, Security Register lock status, and Erase / Program Suspend status.

SR1 and SR2 contain non-volatile bits in locations SR1[7:2] and SR2[6:3,1,0] that control sector protection, OTP Register Protection, Status Register Protection, and Quad mode. Bits located in SR2[7], SR2[2], SR1[1], and SR1[0] are read only volatile bits for suspend, write enable, and busy status. These are updated by the memory control logic. The SR1[1] write enable bit is set only by the Write Enable (06h) command and cleared by the memory control logic when an embedded operation is completed.



Write access to the non-volatile Status Register bits is controlled by the state of the non-volatile Status Register Protect bits SR1[7] and SR2[0] (SRP0, SRP1), the Write Enable command (06h) preceding a Write Status Registers command, and while Quad mode is not enabled, the WP# pin.

A volatile version of bits SR2[6], SR2[1], and SR1[7:2] that control sector protection and Quad Mode is used to control the behavior of these features after power up. During power up or software reset, these volatile bits are loaded from the non-volatile version of the Status Register bits. The Write Enable for Volatile Status Register (50h) command can be used to write these volatile bits when the command is followed by a Write Status Registers (01h/31h/11h) command. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits.

Write access to the volatile SR1, SR2 and SR3 Status Register bits is controlled by the state of the non-volatile Status Register Protect bits SR1[7] and SR2[0] (SRP0, SRP1), the Write Enable for Volatile Status Register command (50h) preceding a Write Status Registers command, and the WP# pin while Quad mode is not enabled.

Table 11 Status Register-1 (SR1)

Bits	Field	Function	Туре	Default State	Description
7	SRP0	Status Register Protect 0		0	0 = WP# input has no effect or Power Supply Lock Down mode 1 = WP# input can protect the Status Register or OTP Lock Down.
6	SEC	Sector / Block Protect	Non-volatile and	0	0 = BP2-BP0 protect 64-kB blocks 1 = BP2-BP0 protect 4-kB sectors
5	ТВ	Top / Bottom protect	Volatile versions	0	0 = BP2-BP0 protect from the Top down 1 = BP2-BP0 protect from the Bottom up
4	BP2			0	
3	BP1	Block Protect Bits		0	000b = No protection
2	BP0			0	
1	WEL	Write Enable Latch	Volatile, Read only	0	0 = Not Write Enabled, no embedded operation can start 1 = Write Enabled, embedded operation can start
0	BUSY	Embedded Operation Status	Volatile, Read only	0	0 = Not Busy, no embedded operation in progress 1 = Busy, embedded operation in progress



Table 12 Status Register-2 (SR2)

Bits	Field	Function	Туре	Default State	Description		
7	SUS1	Erase Suspend Status	Volatile, Read Only	0	0 = Erase not suspended 1 = Erase suspended		
6	СМР	Complement Protect	Non-volatile and Volatile versions	0	0 = Normal Protection Map 1 = Complementary Protection Map		
5	LB3	Convity Dogistor		0	OTP Lock Bits 3:1 for Security Registers 3:1		
4	LB2	Security Register Lock Bits	OTP	0	0 = Security Register not protected		
3	LB1	LOCK DIG		0	1 = Security Register protected		
2	SUS2	Program Suspend	Volatile, Read	0	0 = Program not suspended		
	0002	Status	Only	0	1 = Program suspended		
1	QE	Quad Enable	Non-volatile and Volatile	0	0 = Quad Mode Not Enabled, the WP# pin and HOLD# are enabled 1 = Quad Mode Enabled, the IO2 and IO3 pins are enabled, and WP# and HOLD# functions are disabled		
0	SRP1	Status Register Protect 1	versions	0	0 = SRP1 selects whether WP# input has effect on protection of the status register 1 = SRP1 selects Power Supply Lock Down or OTP Lock Down mode		

Table 13 Status Register-3 (SR3)

Bits	Field	Function	Туре	Default State	Description
7	Reserve			0	
6	DRV1 ⁽¹⁾	Output Driver	Non-volatile	0	The DRV1 & DRV0 bits are used to determine the
5	DRV0 ⁽¹⁾	Strength	versions	0	output driver strength for the Read operations.
4				0	
3	Reserve			0	
2	Reserve			0	
1				0	
0	DC	Dummy Configuration	Non-volatile and Volatile versions	0	Selects the number of dummy cycles.

Note:

(1) Default state for these bits could be modified. please contact sales.



BUSY

BUSY is a read only bit in the status register (SR1[0]) which is set to a "1" state when the device is executing a Page Program, Sector Erase, Block Erase, Chip Erase or Write Status Register instruction. During this time the device will ignore further instructions except for the Read Status Register instruction (see tw, tpp, tse, tbe, and tce in AC Characteristics). When the program, erase or write status register instruction has completed, the BUSY bit will be cleared to a "0" state indicating the device is ready for further instructions.

Write Enable Latch (WEL)

Write Enable Latch (WEL) is a read only bit in the status register (SR1[1]) which is set to a 1 after executing a Write Enable Instruction. The WEL status bit is cleared to a 0 when the device is written disabled. A write disable state occurs upon power-up or after any of the following instructions: Write Disable, Page Program, Sector Erase, Block Erase, Chip Erase and Write Status Register.

Block Protect Bits (BP2, BP1, BP0)

The Block Protect Bits (BP2, BP1, BP0) are non-volatile read / write bits in the Status Register (SR1[4:2]) that provide Write Protection control and status. Block Protect bits can be set using the Write Status Registers Command (see t_W in Section 8.5). All, none or a portion of the memory array can be protected from Program and Erase commands (see Section 6.4.2, Block Protection Maps). The factory default setting for the Block Protection Bits is 0 (none of the array is protected.)

Top / Bottom Block Protect (TB)

The non-volatile Top / Bottom bit (TB SR1[5]) controls whether the Block Protect Bits (BP2, BP1, BP0) protect from the Top (TB=0) or the Bottom (TB=1) of the array as shown in Section 6.4.2, Block Protection Maps. The factory default setting is TB=0. The TB bit can be set with the Write Status Registers Command depending on the state of the SRP0, SRP1 and WEL bits.

Sector / Block Protect (SEC)

The non-volatile Sector / Block Protect bit (SEC SR1[6]) controls if the Block Protect Bits (BP2, BP1, BP0) protect either 4-kB Sectors (SEC=1) or 64-kB Blocks (SEC=0) of the array as shown in Section 6.4.2, Block Protection Maps. The default setting is SEC=0.

Complement Protect (CMP)

The Complement Protect bit (CMP SR2[6]) is a non-volatile read / write bit in the Status Register (SR2[6]). It is used in conjunction with SEC, TB, BP2, BP1 and BP0 bits to provide more flexibility for the array protection. Once CMP is set to 1, previous array protection set by SEC, TB, BP2, BP1 and BP0 will be reversed. For instance, when CMP=0, a top 4-kB sector can be protected while the rest of the array is not; when CMP=1, the top 4-kB sector will become unprotected while the rest of the array become read-only. Refer to Section 6.4.2, Block Protection Maps for details. The default setting is CMP=0.

The Status Register Protect (SRP1, SRP0) B

The Status Register Protect bits (SRP1 and SRP0) are non-volatile read / write bits in the Status Register (SR2[0] and SR1[7]). The SRP bits control the method of write protection: software protection, hardware protection, power supply lock-down, or one time programmable (OTP) protection.



Table 14 Status Register Protect

SRP1	SRP0	WP#	Status Register	Description
0	0	X	Software Protection	WP# pin has no control. SR1, SR2 and SR3 can be written to after a Write
	0	^	Software Protection	Enable command, WEL=1. [Factory Default]
0	1	0	Hardware Protected	When WP# pin is low the SR1, SR2 and SR3 are locked and cannot be
	'	O	Tialuwale Flotecteu	written.
0	1	1	Hardware Unprotected	When WP# pin is high SR1, SR2 and SR3 are unlocked and can be
	ı	ı	Hardware Oriprotected	written to after a Write Enable command, WEL=1.
1	0	X	Power Supply Lock Down	SR1, SR2 and SR3 are protected and cannot be written to again until the
	0	^	Fower Supply Lock Down	next power-down, power-up cycle. (1)
1	1	X	One Time Program (2)	SR1, SR2 and SR3 are permanently protected and cannot be written.

Notes:

- (1) When SRP1, SRP0 = (1, 0), a power-down, power-up, or Software Reset cycle will change SRP1, SRP0 to (0, 0) state.
- (2) The One-Time Program feature is available upon special order. Contact Zbit for details.
- (3) Busy, WEL, SUS1 and SUS2 (SR1[1:0], SR2[2] and SR2[7]) are volatile read only status bits that are never affected by the Write Status Registers command.
- (4) The non-volatile version of DRV1, DRV0, DC, CMP, QE, SRP1, SRP0, SEC, TB, and BP2-BP0 (SR3[6:5,0], SR2[6,1,0] and SR1[6:2]) bits and the OTP LB3-LB1 bits are not writable when protected by the SRP bits and WP# as shown in the table. The non-volatile version of these Status Register bits is selected for writing when the Write Enable (06h) command precedes the Write Status Registers (01h) command.
- (5) The volatile version of DRV1, DRV0, DC, CMP, QE, SRP1, SRP0, SEC, TB, and BP2-BP0 (SR3[6:5,0], SR2[6,1,0] and SR1[6:2]) bits are not writable when protected by the SRP bits and WP# as shown in the table. The volatile version of these Status Register bits is selected for writing when the Write Enable for volatile Status Register (50h) command precedes the Write Status Registers (01h) command. There is no volatile version of the LB3-LB1 bits and these bits are not affected by a volatile Write Status Registers command.

Erase / Program Suspend Status (SUS1, SUS2)

The Suspend Status bit is a read only bit in the status register (SR2[7] and SR2[2]) that is set to 1 after executing an Erase / Program Suspend (75h) command. The SUS status bits are cleared to 0 by Erase / Program Resume (7Ah) command as well as a power-down, power-up cycle.

Security Register Lock Bits (LB3, LB2, LB1)

The Security Register Lock Bits (LB3, LB2, LB1) are non-volatile One Time Program (OTP) bits in Status Register (SR2[5:2]) that provide the write protect control and status to the Security Registers. The default state of LB[3:1] is 0, Security Registers 1 to 3 are unlocked. LB[3:1] can be set to 1 individually using the Write Status Registers command. LB[3:1] are One Time Programmable (OTP), once it's set to 1, the corresponding 256-byte Security Register will become read-only permanently.

Quad Enable (QE)

The Quad Enable (QE) bit is a non-volatile read / write bit in the Status Register (SR2[1]) that allows Quad SPI operation. When the QE bit is set to a 0 state (factory default), the WP# pin and HOLD# are enabled. When the QE bit is set to a 1, the Quad IO2 and IO3 pins are enabled, and WP# and HOLD# functions are disabled.

Note: If the WP# or HOLD# pins are tied directly to the power supply or ground during standard SPI or Dual SPI operation, the QE bit should never be set to a 1.

Dummy Configuration (DC)

The Dummy Configuration (DC) bit is non-volatile, which selects the number of dummy cycles between the end of address and the start of read data output. Dummy cycles provide additional latency



that is needed to complete the initial read access of the flash array before data can be returned to the host system. Some read commands require additional dummy cycles as the SCLK frequency increases.

The following dummy cycle tables provide different dummy cycle settings that are configured.

Command	DC bit	Numbers of Dummy Cycles	Frequency (MHz)	
BBh	0 (default)	4	104	
DDII	1	8	133R ⁽¹⁾	
ED!	0 (default)	6	104	
EBh	1	10	133R ⁽¹⁾	

Note:

(1)"R" means VCC range=3.0V~3.6V.

Output Driver Strength (DRV1, DRV0)

The DRV1 & DRV0 bits are used to determine the output driver strength for the Read operations.

DRV1, DRV0	Driver Strength
0, 0	50% (default)
0, 1	25%
1, 0	75%
1, 1	100%



Write Protection

Applications that use non-volatile memory must take into consideration the possibility of noise and other adverse system conditions that may compromise data integrity. To address this concern the HG25Q16B provides the following data protection mechanisms:

Write Protect Features

- Device resets when V_{CC} is below threshold
- Time delay write disable after Power-Up
- Write enable / disable commands and automatic write disable after erase or program
- Command length protection
 - -All commands that Write, Program or Erase must complete on a byte boundary (CS# driven high after a full 8 bits have been clocked) otherwise the command will be ignored.
- Software and Hardware write protection using Status Register control
 - -WP# input protection
 - -Lock Down write protection until next power-up or Software Reset
 - -One-Time Program (OTP) write protection
- Write Protection using the Deep Power-Down command

Upon power-up or at power-down, the HG25Q16B will maintain a reset condition while VCC is below the threshold value of VWI, (see Figure 36). While reset, all operations are disabled and no commands are recognized. During power-up and after the VCC voltage exceeds Vcc(min), all commands are further disabled for a time delay of tVSL. Note that the chip select pin (CS#) must track the VCC supply level at power-up until the VCC-min level and tVSL time delay is reached. If needed a pull-up resistor on CS# can be used to accomplish this.

After power-up the device is automatically placed in a write-disabled state with the Status Register Write Enable Latch (WEL) set to a 0. A Write Enable command must be issued before a Page Program, Sector Erase, Block Erase, Chip Erase or Write Status Registers command will be accepted. After completing a program, erase or write command the Write Enable Latch (WEL) is automatically cleared to a write-disabled state of 0.

Software controlled main flash array write protection is facilitated using the Write Status Registers command to write the Status Register (SR1,SR2) and Block Protect (SEC, TB, BP2, BP1 and BP0) bits.

The BP method allows a portion as small as 4-kB sector or the entire memory array to be configured as read only. Used in conjunction with the Write Protect (WP#) pin, changes to the Status Register can be enabled or disabled under hardware control. See the Table 14 for further information.

Additionally, the Deep Power-Down (DPD) command offers an alternative means of data protection as all commands are ignored during the DPD state, except for the Release from Deep-Power-Down (RES ABh) command. Thus, preventing any program or erase during the DPD state.



Block Protection Maps

Table 15 HG25Q16B Block Protection (CMP = 0)

	Stat	us Regist	er ⁽¹⁾		HG25Q1	HG25Q16B (16 Mbit) Block Protection (CMP=0) (2)			
SEC	ТВ	BP2	BP1	BP0	Protected Block(s)	Protected Addresses	Protected Density	Protected Portion	
Х	Х	0	0	0	None	None	None	None	
0	0	0	0	1	31	1F0000h – 1FFFFFh	64 kB	Upper 1/32	
0	0	0	1	0	30 and 31	1E0000h – 1FFFFFh	128 kB	Upper 1/16	
0	0	0	1	1	28 thru 31	1C0000h – 1FFFFFh	256 kB	Upper 1/8	
0	0	1	0	0	24 thru 31	180000h – 1FFFFFh	512 kB	Upper 1/4	
0	0	1	0	1	16 thru 31	100000h – 1FFFFFh	1 MB	Upper 1/2	
0	1	0	0	1	0	000000h – 00FFFFh	64 kB	Lower 1/32	
0	1	0	1	0	0 and 1	000000h – 01FFFFh	128 kB	Lower 1/16	
0	1	0	1	1	0 thru 3	000000h – 03FFFFh	256 kB	Lower 1/8	
0	1	1	0	0	0 thru 7	000000h – 07FFFFh	512 kB	Lower 1/4	
0	1	1	0	1	0 thru 15	000000h – 0FFFFh	1 MB	Lower 1/2	
Х	Х	1	1	Х	0 thru 31	000000h – 1FFFFFh	2 MB	All	
1	0	0	0	1	31	1FF000h – 1FFFFFh	4 kB	Upper 1/512	
1	0	0	1	0	31	1FE000h – 1FFFFFh	8 kB	Upper 1/256	
1	0	0	1	1	31	1FC000h – 1FFFFFh	16 kB	Upper 1/128	
1	0	1	0	Х	31	1F8000h – 1FFFFFh	32 kB	Upper 1/64	
1	1	0	0	1	0	000000h – 000FFFh	4 kB	Lower 1/512	
1	1	0	1	0	0	000000h – 001FFFh	8 kB	Lower 1/256	
1	1	0	1	1	0	000000h – 003FFFh	16 kB	Lower 1/128	
1	1	1	0	Х	0	000000h – 007FFFh	32 kB	Lower 1/64	

Notes:

⁽¹⁾X = don't care.

⁽²⁾ If any Erase or Program command specifies a memory region that contains protected data portion, this command will be ignored.



Table 16 HG25Q16B Block Protection (CMP = 1)

Status Register (1)					HG25Q16B (16 Mbit) Block Protection (CMP=1) (2)					
SEC	тв	BP2	BP1	BP0	Protected Block(s)	Protected Addresses	Protected Density	Protected Portion		
Х	Х	0	0	0	0 thru 31	000000h – 1FFFFFh	2 MB	All		
0	0	0	0	1	0 thru 30	000000h – 1EFFFFh	1984 kB	Lower 31/32		
0	0	0	1	0	0 thru 29	000000h – 1DFFFFh	1920 kB	Lower 15/16		
0	0	0	1	1	0 thru 27	000000h – 1BFFFFh	1792 kB	Lower 7/8		
0	0	1	0	0	0 thru 23	000000h – 17FFFFh	1536 kB	Lower 3/4		
0	0	1	0	1	0 thru 15	000000h – 0FFFFh	1 MB	Lower 1/2		
0	1	0	0	1	1 thru 31	010000h – 1FFFFFh	1984 kB	Upper 31/32		
0	1	0	1	0	2 thru 31	020000h – 1FFFFFh	1920 kB	Upper 15/16		
0	1	0	1	1	4 thru 31	040000h – 1FFFFFh	1792 kB	Upper 7/8		
0	1	1	0	0	8 thru 31	080000h – 1FFFFFh	1536 kB	Upper 3/4		
0	1	1	0	1	16 thru 31	100000h – 1FFFFFh	1 MB	Upper 1/2		
Х	Х	1	1	Х	None	None	None	None		
1	0	0	0	1	0 thru 31	000000h – 1FEFFFh	2044 kB	Lower 511/512		
1	0	0	1	0	0 thru 31	000000h – 1FDFFFh	2040 kB	Lower 255/256		
1	0	0	1	1	0 thru 31	000000h – 1FBFFFh	2032 kB	Lower 127/128		
1	0	1	0	Х	0 thru 31	000000h – 1F7FFFh	2016 kB	Lower 63/64		
1	1	0	0	1	0 thru 31	001000h – 1FFFFFh	2044 kB	Upper 511/512		
1	1	0	1	0	0 thru 31	002000h – 1FFFFFh	2040 kB	Upper 255/256		
1	1	0	1	1	0 thru 31	004000h – 1FFFFFh	2032 kB	Upper 127/128		
1	1	1	0	Х	0 thru 31	008000h – 1FFFFFh	2016 kB	Upper 63/64		

Notes:

(1)X = don't care.

(2)If any Erase or Program command specifies a memory region that contains protected data portion, this command will be ignored.



Page Program

To program one data byte, two instructions are required: Write Enable (WREN), which is one byte, and a Page Program (PP) sequence, which consists of four bytes plus data. This is followed by the internal Program cycle (of duration tPP). To spread this overhead, the Page Program (PP) instruction allows up to 256 bytes to be programmed at a time (changing bits from 1 to 0), provided that they lie in consecutive addresses on the same page of memory.

Sector Erase, Block Erase and Chip Erase

The Page Program (PP) instruction allows bits to be reset from 1 to 0. Before this can be applied, the bytes of memory need to be erased to all 1s (FFh). This can be achieved a sector at a time, using the Sector Erase (SE) instruction, a block at a time using the Block Erase (BE) instruction or throughout the entire memory, using the Chip Erase (CE) instruction. This starts an internal Erase cycle (of duration tSE tBE or tCE). The Erase instruction must be preceded by a Write Enable (WREN) instruction.

Polling during a Write, Program or Erase Cycle

A further improvement in the time to Write Status Register (WRSR), Program (PP) or Erase (SE, BE or CE) can be achieved by not waiting for the worst case delay (tW, tPP, tSE, tBE or tCE). The Write In Progress (WIP) bit is provided in the Status Register so that the application program can monitor its value, polling it to establish when the previous Write cycle, Program cycle or Erase cycle is complete.

Active Power, Stand-by Power and Deep Power-Down Modes

When Chip Select (CS#) is Low, the device is enabled, and in the Active Power mode. When Chip Select (CS#) is High, the device is disabled, but could remain in the Active Power mode until all internal cycles have completed (Program, Erase, Write Status Register). The device then goes into the Standby Power mode. The device consumption drops to ICC1.

The Deep Power-down mode is entered when the specific instruction (the Enter Deep Power-down Mode (DP) instruction) is executed. The device consumption drops further to ICC2. The device remains in this mode until another specific instruction (the Release from Deep Power-down Mode and Read Device ID (RDI) instruction) is executed.

All other instructions are ignored while the device is in the Deep Power-down mode. This can be used as an extra software protection mechanism, when the device is not in active use, to protect the device from inadvertent Program or Erase instructions.



INSTRUCTIONS

The instruction set of the HG25Q16B consists of thirty-five basic instructions that are fully controlled through the SPI bus. Instructions are initiated with the falling edge of Chip Select (CS#). The first byte of data clocked into the DI input provides the instruction code. Data on the DI input is sampled on the rising edge of clock with most significant bit (MSB) first.

Instructions vary in length from a single byte to several bytes and may be followed by address bytes, data bytes, dummy bytes (don't care), and in some cases, a combination. Instructions are completed with the rising edge of edge CS#. Clock relative timing diagrams for each instruction are included in figures 7.1 through 7.32. All read instructions can be completed after any clocked bit. However, all instructions that Write, Program or Erase must complete on a byte boundary (CS driven high after a full 8-bits have been clocked) otherwise the instruction will be ignored. This feature further protects the device from inadvertent writes. Additionally, while the memory is being programmed or erased, or when the Status Register is being written, all instructions except for Read Status Register and Erase/Program Suspend will be ignored until the program or erase cycle completes.



Table 17 Command Set (Configuration, Status, Erase, Program Instructions (1), SPI Mode)

Command Name	BYTE 1 (Instruction)	BYTE 2	BYTE 3	BYTE 4	BYTE 5	BYTE 6
Read Status Register-1	05h	SR1[7:0] (2)				
Read Status Register-2	35h	SR2[7:0] (2)				
Read Status Register-3	15h	SR3[7:0] (2)				
Write Enable	06h					
Write Enable for Volatile Status Register	50h					
Write Disable	04h					
Write Status Registers-1	01h	SR1[7:0]				
Write Status Registers-2	31h	SR2[7:0]				
Write Status Registers-3	11h	SR3[7:0]				
Set Burst with Wrap	77h	xxh	xxh	xxh	W[7:0] ⁽³⁾	
Page Program	02h	A23—A16	A15—A8	A7—A0	D7—D0	
Quad Page Program	32h	A23—A16	A15—A8	A7—A0	D7—D0 ⁽⁴⁾	
Sector Erase (4 KB)	20h	A23—A16	A15—A8	A7—A0		
Block Erase (32 KB)	52h	A23—A16	A15—A8	A7—A0		
Block Erase (64 KB)	D8h	A23—A16	A15—A8	A7—A0		
Chip Erase	C7h/60h					
Erase/Program Suspend	75h					
Erase/Program Resume	7Ah					
Enable Reset	66h					
Reset Device	99h					

Notes:

- (1) Data bytes are shifted with Most Significant Bit first. Byte fields with data in parenthesis "()" indicate data being read from the device on the DO pin.
- (2) Status Register contents will repeat continuously until CS# terminates the command.
- (3) Set Burst with Wrap Input format.

$$IO0 = x, x, x, x, x, x, W4, x$$

$$IO1 = x, x, x, x, x, x, W5, x$$

$$IO2 = x, x, x, x, x, x, W6 x$$

$$103 = x, x, x, x, x, x, x, x, x$$

(4) Quad Page Program Input Data:

IO0 = (D4, D0,...)

IO1 = (D5, D1,...)

IO2 = (D6, D2,...)

IO3 = (D7,D3,...)



Table 18 Command Set (Read Instructions (1), SPI Mode)

Command Name	BYTE 1 (Instruction)	BYTE 2	BYTE 3	BYTE 4	BYTE 5	BYTE 6
Read Data	03h	A23—A16	A15—A8	A7—A0	(D7—D0,)	
Fast Read	0Bh	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,)
Fast Read Dual Output	3Bh	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,) ⁽¹⁾
Fast Read Quad Output	6Bh	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,) ⁽³⁾
Fast Read Dual I/O	BBh	A23—A8 ⁽²⁾	A7—A0,M7 —M0 ⁽²⁾	(D7—D0,) ⁽¹⁾		
Fast Read Quad I/O	EBh	A23—A0,M7 —M0 ⁽⁴⁾	(x,x,x,x,D7— D0,)	(D7—D0,) ⁽³⁾		

Notes:

(1) Dual Output data

IO0 = (D6, D4, D2, D0)

IO1 = (D7, D5, D3, D1)

(2)Dual Input Address

IO0 = A22, A20, A18, A16, A14, A12, A10, A8 A6, A4, A2, A0, M6, M4, M2, M0

IO1 = A23, A21, A19, A17, A15, A13, A11, A9 A7, A5, A3, A1, M7, M5, M3, M1

(3)Quad Output Datal

O0 = (D4, D0,)

IO1 = (D5, D1,)

IO2 = (D6, D2,)

IO3 = (D7, D3,)

(4) Quad Input Address

IO0 = A20, A16, A12, A8, A4, A0, M4, M0

IO1 = A21, A17, A13, A9, A5, A1, M5, M1

IO2 = A22, A18, A14, A10, A6, A2, M6, M2

IO3 = A23, A19, A15, A11, A7, A3, M7, M3



Table 19 Command Set (Read ID, OTP Instructions (1), SPI Mode)

Command Name	BYTE 1 (Instruction)	BYTE 2	BYTE 3	BYTE 4	BYTE 5	BYTE 6
Deep Power-down	B9h					
Release Power down / Device ID	ABh	dummy	dummy	dummy	Device ID ⁽¹⁾	
Manufacturer/ Device ID ⁽²⁾	90h	dummy	dummy	00h	Manufacturer	Device ID
JEDEC ID	9Fh	Manufacturer	Memory Type	Capacity		
Read SFDP Register	5Ah	00h	00h	A7—A0	dummy	(D7—D0,)
Read Security Registers ⁽³⁾	48h	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,)
Erase Security Registers ⁽³⁾	44h	A23—A16	A15—A8	A7—A0		
Program Security Registers ⁽³⁾	42h	A23—A16	A15—A8	A7—A0	D7—D0,	
Read Unique ID	4Bh	dummy	dummy	dummy	dummy	(ID127-ID0)

Notes:

- (1) The Device ID will repeat continuously until CS# terminates the command.
- (2) See Section 6.4.1, Legacy Device Identification Commands on page 51 for Device ID information. The 90h instruction is followed by an address. Address = 0 selects Manufacturer ID as the first returned data as shown in the table. Address = 1 selects Device ID as the first returned data followed by Manufacturer ID.
- (3) Security Register Address:

Security Register 0: A23-16 = 00h; A15-8 = 00h; A7-0 = byte address Security Register 1: A23-16 = 00h; A15-8 = 10h; A7-0 = byte address Security Register 2: A23-16 = 00h; A15-8 = 20h; A7-0 = byte address Security Register 3: A23-16 = 00h; A15-8 = 30h; A7-0 = byte address

Table 20⁽¹⁾ Manufacturer and Device Identification (HG25Q16B)

OP Code	Data1	Data2	Data3
ABh	Device ID = 14h	-	-
90h	Manufacturer ID = 5E	Device ID = 14h	-
9Fh	Manufacturer ID = 5E	Memory Type =40h	Capacity = 15h

Notes: Please contact sales for more information



Configuration and Status Commands

Read Status Register (05h/35h/15h)

The Read Status Register commands allow the 8-bit Status Registers to be read. The command is entered by driving CS# low and shifting the instruction code "05h" for Status Register-1, "35h" for Status Register-2, "15h" for Status Register-3 into the DI pin on the rising edge of CLK. The Status Register bits are then shifted out on the DO pin at the falling edge of CLK with most significant bit (MSB) first as shown in Figure 4. The Status Register bits are shown in Section 6.2, Status Registers.

The Read Status Register-1 (05h) command may be used at any time, even during a Program, Erase, or Write Status Registers cycle. This allows the BUSY status bit to be checked to determine when the operation is complete and if the device can accept another command.

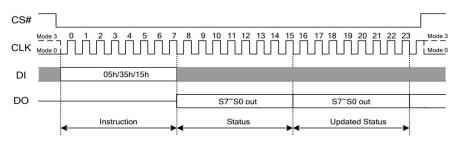


Figure 4 Read Status Register Instruction

Write Enable (06h)

The Write Enable instruction (Figure 5) sets the Write Enable Latch (WEL) bit in the Status Register to a 1. The WEL bit must be set prior to every Page Program, Sector Erase, Block Erase, Chip Erase and Write Status Register instruction. The Write Enable instruction is entered by driving CS# low, shifting the instruction code "06h" into the Data Input (DI) pin on the rising edge of CLK, and then driving CS#high.

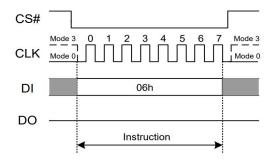


Figure 5 Write Enable Instruction



Write Enable for Volatile Status Register (50h)

The non-volatile Status Register bits described in section 6.2 can also be written to as volatile bits. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. The Write Enable for Volatile Status Register command must be issued prior to a Write Status Register command and any other commands can't be inserted between them. Otherwise, Write Enable for Volatile Status Register will be cleared. Write Enable for Volatile Status Register instruction (Figure 6) will not set the Write Enable Latch (WEL)bit, it is only valid for the Write Status Register instruction to change the volatile Status Register bit values.

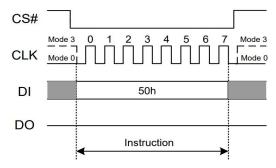


Figure 6 Write Enable for Volatile Status Register Instruction

Write Disable (04h)

The Write Disable instruction (Figure 7) resets the Write Enable Latch (WEL) bit in the Status Register to a 0. The Write Disable instruction is entered by driving CS# low, shifting the instruction code "04h" into the DI pin and then driving CS# high. Note that the WEL bit is automatically reset after Power-up and upon completion of the Write Status Register, Page Program, Sector Erase, Block Erase and Chip Erase instructions.

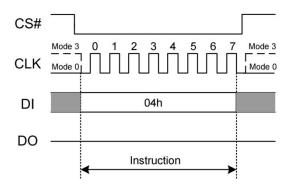


Figure 7 Write Disable Instruction



Write Status Register (01h/31h/11h)

The Write Status Registers command allows the Status Registers to be written. Only non-volatile Status Register bits SRP0, SEC, TB, BP2, BP1, BP0 (SR1[7:2]) CMP, LB3, LB2, LB1, QE, SRP1 (SR2[6:3],SR2[1,0]), and the bits DRV1, DRV0, DC (SR3[6:5,0]) can be written. All other Status Register bit locations are read-only and will not be affected by the Write Status Registers command. LB[3:1] are non-volatile OTP bits; once each is set to 1, it cannot be cleared to 0. The Status Register bits are shown in Section 6.2, Status Registers. Any reserved bits should only be written to their default value.

To write non-volatile Status Register bits, a standard Write Enable (06h) command must previously have been executed for the device to accept the Write Status Registers Command (Status Register bit WEL must equal 1). Once write enabled, the command is entered by driving CS# low, sending the instruction code "01h/31h/11h", and then writing the Status Register data bytes as illustrated in Figure 8

To write volatile Status Register bits, a Write Enable for Volatile Status Register (50h) command must have been executed prior to the Write Status Registers command (Status Register bit WEL remains 0). However, SRP1 and LB3, LB2, LB1 cannot be changed because of the OTP protection for these bits. Upon power-off, the volatile Status Register bit values will be lost, and the non-volatile Status Register bit values will be restored when power on again.

To complete the Write Status Registers command, the CS# pin must be driven high after the eighth bit of a data value is clocked in (CS# must be driven high on an 8-bit boundary). If this is not done the Write Status Registers command will not be executed.

During non-volatile Status Register write operation (06h combined with 01h/31h/11h), after CS# is driven high, the self-timed Write Status Register cycle will commence for a time duration of tW (See AC Characteristics). While the Write Status Register cycle is in progress, the Read Status Register instruction may still be accessed to check the status of the BUSY bit. The BUSY bit is a 1 during the Write Status Register cycle and a 0 when the cycle is finished and ready to accept other instructions again. After the Write Status Register cycle has finished, the Write Enable Latch (WEL) bit in the Status Register will be cleared to 0.

During volatile Status Register write operation (50h combined with 01h/31h/11h), after CS# is driven high, the Status Register bits will be refreshed to the new values within the time period of tSHSL2 (See AC Characteristics). BUSY bit will remain 0 during the Status Register bit refresh period.

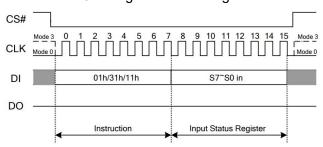


Figure 8 Write Status Register Instruction



Program and Erase Commands

Page Program (PP) (02h)

The Page Program instruction allows up to 256 bytes of data to be programmed at previously erased to all 1s (FFh) memory locations. A Write Enable instruction must be executed before the device will accept the Page Program Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low then shifting the instruction code "02h" followed by a 24-bit address (A23-A0) and at least one data byte, into the DI pin. The CS# pin must be held low for the entire length of the instruction while data is being sent to the device. The Page Program instruction sequence is shown in Figure 9

If an entire 256 byte page is to be programmed, the last address byte (the 8 least significant address bits) should be set to 0. If the last address byte is not zero, and the number of clocks exceeds the remaining page length, the addressing will wrap to the beginning of the page. In some cases, less than 256 bytes (a partial page) can be programmed without having any effect on other bytes within the same page. One condition to perform a partial page program is that the number of clocks cannot exceed the remaining page length. If more than 256 bytes are sent to the device the addressing will wrap to the beginning of the page and overwrite previously sent data.

As with the write and erase instructions, the CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the Page Program instruction will not be executed. After CS# is driven high, the self-timed Page Program instruction will commence for a time duration of tpp (See AC Characteristics). While the Page Program cycle is in progress, the Read Status Register instruction may still be accessed for checking the status of the BUSY bit. The BUSY bit is a 1 during the Page Program cycle and becomes a 0 when the cycle is finished and the device is ready to accept other instructions again. After the Page Program cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Page Program instruction will not be executed if the addressed page is protected by the Block Protect (TB, SEC, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

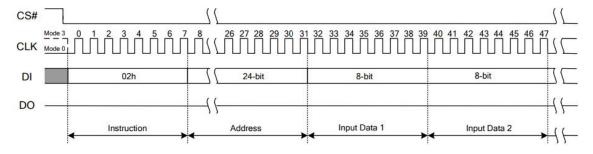


Figure 9 a Page Program Instruction



Quad Input Page Program (32h)

The Quad Input Page Program instruction allows up to 256 byte of data to be programmed at previously erased (FFh) memory locations using four pins: IO0, IO1, IO2 and IO3. The Quad Input Page Program can improved performance for PROM Programmer and applications that have slow clock speeds<5MHz. Systems with faster clock speed will not realize much benefit for the Quad Input Page Program instruction since the inherent page program time is much greater than the time it take to clock-in the data.

To use Quad Page Program the Quad Enable in Status Register-2 must be set (QE=1). A Write Enable instruction must be executed before the device will accept the Quad Page Program instruction (Status Register-1, WEL=1). The instruction is initiated by driving the CS# pin low then shifting the instruction code "32h" followed by a 24-bit address (A23-0) and at least one data byte, into the IO pins. The CS# pin must be held low for entire length of the instruction while data is being sent to the device. All other functions of Quad Page Program are identical to standard Page Program. The Quad Page Program instructions sequence is shown in Figure 10.

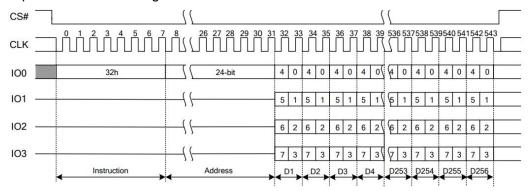


Figure 10 Quad Page Program Instruction



Sector Erase (SE) (20h)

The Sector Erase instruction sets all memory within a specified sector (4K-bytes) to the erased state of all 1s (FFh). A Write Enable instruction must be executed before the device will accept the Sector Erase Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low and shifting the instruction code "20h" followed a 24-bit sector address (A23-A0). The Sector Erase instruction sequence is shown in Figure 11.

The CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the Sector Erase instruction will not be executed. After CS# is driven high, the self-timed Sector Erase instruction will commence for a time duration of tSE (See AC Characteristics). While the Sector Erase cycle is in progress, the Read Status Register instruction may still be accessed for checking the status of the BUSY bit. The BUSY bit is a 1 during the Sector Erase cycle and becomes a 0 when the cycle is finished and the device is ready to accept other instructions again. After the Sector Erase cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Sector Erase instruction will not be executed if the addressed page is protected by the Block Protect (TB, SEC, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

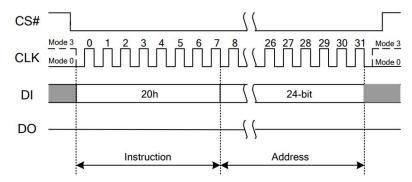


Figure 11 Sector Erase Instruction



Block Erase (BE) (D8h) and Half Block Erase (52h)

The Block Erase instruction sets all memory within a specified block (64K-bytes) or half block (32K-bytes) to the erased state of all 1s (FFh). A Write Enable instruction must be executed before the device will accept the Block Erase Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low and shifting the instruction code "D8h" or "52h" followed a 24-bit block address (A23-A0). The Block Erase instruction sequence is shown in Figure 12.

The CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the Block Erase instruction will not be executed. After CS# is driven high, the self-timed Block Erase instruction will commence for a time duration of tBE (See AC Characteristics). While the Block Erase cycle is in progress, the Read Status Register instruction may still be accessed for checking the status of the BUSY bit.

The BUSY bit is a 1 during the Block Erase cycle and becomes a 0 when the cycle is finished and the device is ready to accept other instructions again. After the Block Erase cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Block Erase instruction will not be executed if the addressed page is protected by the Block Protect (TB, SEC, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

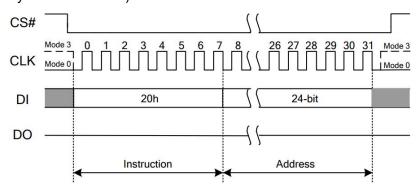


Figure 12 Block Erase Instruction



Chip Erase (CE) (C7h or 60h)

The Chip Erase instruction sets all memory within the device to the erased state of all 1s (FFh). A Write Enable instruction must be executed before the device will accept the Chip Erase Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low and shifting the instruction code "C7h" or "60h". The Chip Erase instruction sequence is shown in Figure 13.

The CS# pin must be driven high after the eighth bit has been latched. If this is not done the Chip Erase instruction will not be executed. After CS# is driven high, the self-timed Chip Erase instruction will commence for a time duration of tCE (See AC Characteristics). While the Chip Erase cycle is in progress, the Read Status Register instruction may still be accessed to check the status of the BUSY bit. The BUSY bit is a 1 during the Chip Erase cycle and becomes a 0 when finished and the device is ready to accept other instructions again. After the Chip Erase cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Chip Erase instruction will not be executed if any page is protected by the Block Protect (SEC, TB, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

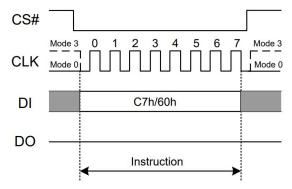


Figure 13 Chip Erase Instruction



Erase / Program Suspend (75h)

The Erase / Program Suspend command allows the system to interrupt a Sector or Block Erase operation (except Erase Security Registers), then read from or program data to any other sector. The Erase / Program Suspend command also allows the system to interrupt a Page Program operation (except Program Security Registers) and then read data from any other page. The Erase / Program Suspend command sequence is shown in Figure 14.

The Write Status Registers command (01h, 31h, 11h), Program Security Registers command (42h) and Erase commands (20h, 52h, D8h, C7h, 60h, 44h) are not allowed during Erase Suspend. Erase Suspend is valid only during the Sector or Block erase operation. If written during the Chip Erase operation, the Erase Suspend command is ignored. The Write Status Registers command (01h, 31h, 11h), Erase commands (20h, 52h, D8h, C7h, 60h, 44h) and Program commands (02h, 32h, 42h) are not allowed during Program Suspend. Program Suspend is valid during the Page Program or Quad Page Program operation.

The Erase / Program Suspend command 75h will be accepted by the device only if the SUS bit in the Status Register equals to 0 and the BUSY bit equals to 1 while a Sector or Block Erase or a Page Program HG25Q16B 39 operation is on-going. If the SUS bit equals to 1 or the BUSY bit equals to 0, the Suspend command will be ignored by the device. Program or Erase command for the sector that is being suspended will be ignored.

A maximum of time of tSUS (Section 8.5, AC Electrical Characteristics) is required to suspend the erase or program operation. The BUSY bit in the Status Register will be cleared from 1 to 0 within tSUS and the SUS bit in the Status Register will be set from 0 to 1 immediately after Erase/Program Suspend. For a previously resumed Erase/Program operation, it is also required that the Suspend command 75h is not issued earlier than a minimum of time of tSUS following the preceding Resume command 7Ah.

Unexpected power off during the Erase / Program suspend state will reset the device and release the suspend state. SUS bit in the Status Register will also reset to 0. The data within the page, sector or block that was being suspended may become corrupted. It is recommended for the user to implement system design techniques to prevent accidental power interruption, provide non-volatile tracking of in process program or erase commands, and preserve data integrity by evaluating the non-volatile program or erase tracking information during each system power up in order to identify and repair (re-erase and re-program) any improperly terminated program or erase operations.

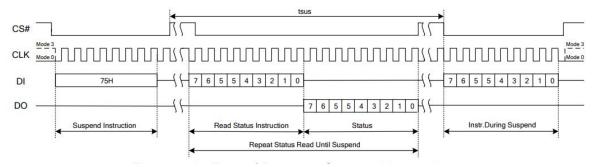


Figure 14 Erase / Program Suspend Instruction



Erase / Program Resume (7Ah)

The Erase / Program Resume command "7Ah" must be written to resume the Sector or Block Erase operation (except Erase Security Registers) or the Page Program operation (except Program Security Registers) after an Erase / Program Suspend. The Resume command "7Ah" will be accepted by the device only if the SUS bit in the Status Register equals to 1 and the BUSY bit equals to 0. After the Resume command is issued the SUS bit will be cleared from 1 to 0 immediately, the BUSY bit will be set from 0 to 1 within 200 ns and the Sector or Block will complete the erase operation or the page will complete the program operation. If the SUS bit equals to 0 or the BUSY bit equals to 1, the Resume command "7Ah" will be ignored by the device. The Erase / Program Resume command sequence is shown in Figure 15. It is required that a subsequent Erase / Program Suspend command not to be issued within a minimum of time of "tsus" following a Resume command.

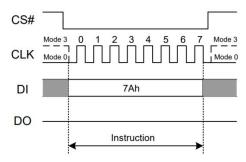


Figure 15 Erase/Program Resume Instruction

Read Commands

Read Data (03h)

The Read Data instruction allows one more data bytes to be sequentially read from the memory. The instruction is initiated by driving the CS# pin low and then shifting the instruction code "03h" followed by a 24-bit address (A23-A0) into the DI pin. The code and address bits are latched on the rising edge of the CLK pin. After the address is received, the data byte of the addressed memory location will be shifted out on the DO pin at the falling edge of CLK with most significant bit (MSB) first. The address is automatically incremented to the next higher address after each byte of data is shifted out allowing for a continuous stream of data. This means that the entire memory can be accessed with a single instruction as long as the clock continues. The instruction is completed by driving CS# high.

The Read Data instruction sequence is shown in Figure 16. If a Read Data instruction is issued while an Erase, Program or Write cycle is in process (BUSY=1) the instruction is ignored and will not have any effects on the current cycle. The Read Data instruction allows clock rates from D.C. to a maximum of f_R (see AC Electrical Characteristics).

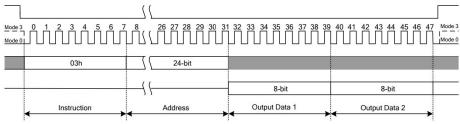
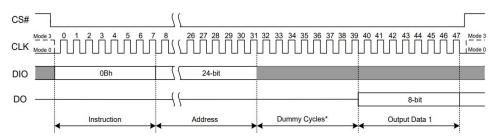


Figure 16 Read Data Instruction



Fast Read (0Bh)

The Fast Read instruction is similar to the Read Data instruction except that it can operate at the highest possible frequency of FR (see AC Electrical Characteristics). This is accomplished by adding eight "dummy" clocks after the 24-bit address as shown in Figure 17. The dummy clocks allow the devices internal circuits additional time for setting up the initial address. During the dummy clocks the data value on the DI pin is a "don't care".



* The default is 8 dummy

Figure 17 Fast Read Instruction

Fast Read Dual Output (3Bh)

The Fast Read Dual Output (3Bh) instruction is similar to the standard Fast Read (0Bh) instruction except that data is output on two pins, DO and DI, instead of just DO. This allows data to be transferred from the HG25Q16B at twice the rate of standard SPI devices. The Fast Read Dual Output instruction is ideal for quickly downloading code from Flash to RAM upon power-up or for applications that cache code-segments to RAM for execution.

Similar to the Fast Read instruction, the Fast Read Dual Output instruction can operate at the highest possible frequency of FR (see AC Electrical Characteristics). This is accomplished by adding eight "dummy" clocks after the 24-bit address as shown in Figure 18. The dummy clocks allow the device's internal circuits additional time for setting up the initial address. The input data during the dummy clocks is "don't care". However, the DI pin should be high-impedance prior to the falling edge of the first data out clock.

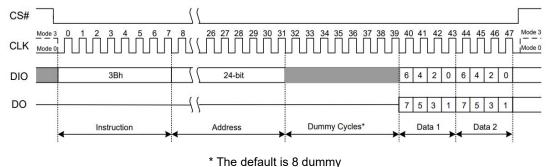


Figure 18 Fast Read Dual Output Instruction Sequence Diagram

Fast Read Quad Output (6Bh)

The Fast Read Quad Output (6Bh) instruction is similar to the Fast Dual Output (3Bh) instruction except that data is output on four pins, IO0, IO1, IO2 and IO3. A Quad enable of status Register-2 must be executed before the device will accept the Fast Read Quad Output Instruction (Status Register bit QE must equal 1). The Fast Read Quad Output Instruction allows data to be transferred from HG25Q16B at four times the rate of standard SPI devices.



The Fast Read Quad Output instruction can operate at the highest possible frequency of FR (see AC Electrical Characteristics). This is accomplished by adding "dummy" clocks after the 24-bit address as shown in Figure 19. The input data during the dummy clocks is "don't care". However, the IO pins should be high-impedance prior to the falling edge of the first data out clock.

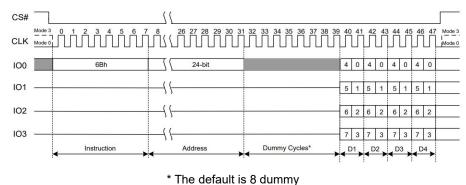


Figure 19 Fast Read Quad Output Instruction

Fast Read Dual I/O (BBh)

The Fast Read Dual I/O (BBh) instruction allows for improved random access while maintaining two IO pins, IO0 and IO1. It is similar to the Fast Read Dual Output (3Bh) instruction but with the capability to input the Address bits (A23-0) two bits per dock. This reduced instruction overhead may allow for code execution (XIP) directly from the Dual SPI in some applications.

Fast Read Dual I/O with "Continuous Read Mode"

The Fast Read Dual I/O instruction can further reduce instruction overhead through setting the "Continuous Read Mode" bits (M7-0) after the input Address bits (A23-0), as shown in Figure 20 The upper nibble of the (M7-4) controls the length of the next Fast Read Dual I/O instruction through the inclusion or exclusion of the first byte instruction code. The lower nibble bits of the (M3-0) are don't care ("X"). However, the IO pins should be high-impedance prior to the falling edge of the first data out clock. It is recommended to input FFFFh on IO0 for the next instruction (16 clocks), to ensure M4 = 1 and return the device to normal operation

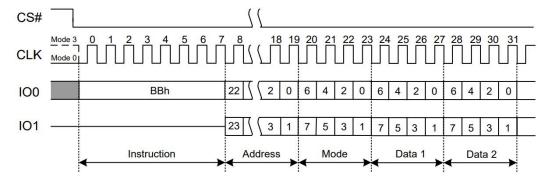


Figure 20 Fast Read Dual I/O Instruction (Initial command or previous M5-4≠10)

Note:

(1)Least significant 4 bits of Mode are don't care and it is optional for the host to drive these bits. The host may turn off drive during these cycles to increase bus turnaround time between Mode bits from host and returning data from the memory



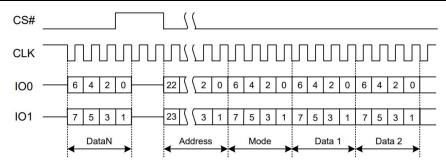


Figure 21 Fast Read Dual I/O Instruction (Initial command or previous M5-4=10)

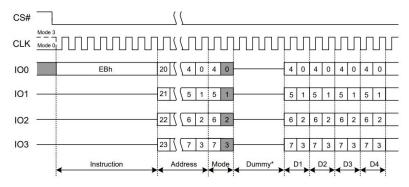
Fast Read Quad I/O (EBh)

The Fast Read Quad I/O (EBh) command is similar to the Fast Read Dual I/O (BBh) command except that address and data bits are input and output through four pins IO0, IO1, IO2 and IO3 and Dummy clock are required prior to the data output. The Quad I/O dramatically reduces instruction overhead allowing faster random access for code execution (XIP) directly from the Quad SPI. The Quad Enable bit (QE) of Status Register-2 must be set to enable the Fast Read Quad I/O Command.

Fast Read Quad I/O with "Continuous Read Mode"

The Fast Read Quad I/O command can further reduce instruction overhead through setting the "Continuous Read Mode" bits (M7-0) and 4-dummy clock 4-bit per clock by IO0, IO1, IO2, IO3 after the input Address bits (A23-0), as shown in Figure 22, Fast Read Quad I/O Command Sequence (Initial command or previous M5-4≠10). The upper nibble of the (M7-4) controls the length of the next Fast Read Quad I/O command through the inclusion or exclusion of the first byte instruction code. The lower nibble bits of the (M3-0) are don't care ("X"). However, the IO pins should be high-impedance prior to the falling edge of the first data out clock.

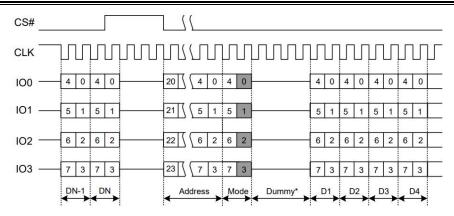
If the "Continuous Read Mode" bits M5-4 = (1,0), then the next Fast Read Quad I/O command (after CS# is raised and then lowered) does not require the EBh instruction code, as shown in Figure 23, Fast Read Quad I/O Command Sequence (Previous command set M5-4 = 10). This reduces the command sequence by eight clocks and allows the Read address to be immediately entered after CS# is asserted low. If the "Continuous Read Mode" bits M5-4 do not equal to (1, 0), the next command (after CS# is raised and then lowered) requires the first byte instruction code, thus returning to normal operation. It is recommended to input FFh on IO0 for the next instruction (8 clocks), to ensure M4=1 and return the device to normal operation.



* the "Continuous Read Mode" bits M7-0 are also considered as dummy clocks

Figure 22 Fast Read Quad I/O Instruction(Initial command or previous M5-4 ≠10)





* the —Continuous Read Modell bits M7-0 are also considered as dummy clocks
Figure 23 Fast Read Quad I/O Instruction(Previous command set M5-4 = 10)

Fast Read Quad I/O with "8/16/32/64-Byte Wrap Around"

The Fast Read Quad I/O command can also be used to access a specific portion within a page by issuing a "Set Burst with Wrap" command prior to EBh. The "Set Burst with Wrap" command can either enable or disable the "Wrap Around" feature for the following EBh commands. When "Wrap Around" is enabled, the data being accessed can be limited to 8/16/32/64-byte section of data. The output data starts at the initial address specified in the command, once it reaches the ending boundary of the 8/16/32/64-byte section, the output will wrap around to the beginning boundary automatically until CS# is pulled high to terminate the command.

The Burst with Wrap feature allows applications that use cache to quickly fetch a critical address and then fill the cache afterwards within a fixed length (8/16/32/64-bytes) of data without issuing multiple read commands.

The "Set Burst with Wrap" command allows three "Wrap Bits", W6-4 to be set. The W4 bit is used to enable or disable the "Wrap Around" operation while W6-5 is used to specify the length of the wrap around section within a page. See Section 7.3.9, Set Burst with Wrap (77h).

Set Burst with Wrap (77h)

The Set Burst with Wrap (77h) command is used in conjunction with "Fast Read Quad I/O" commands to access a fixed length and alignment of 8/16/32/64-bytes of data. Certain applications can benefit from this feature and improve the overall system code execution performance. This command loads the W4,W5,W6 bits. Similar to a Quad I/O command, the Set Burst with Wrap command is initiated by driving the CS# pin low and then shifting the instruction code "77h" followed by 24-dummy bits and 8 "Wrap Bits", W7-0. The command sequence is shown in Figure 24, Set Burst with Wrap Command Sequence. Wrap bit W7 and the lower nibble W3-0 are not used.

14/0 14/5	W	4=0	W4=1(DEFAULT)		
W6, W5	Wrap Around	Wrap Length	Wrap Around	Wrap Length	
0,0	Yes	8-byte	No	N/A	
0,1	Yes	16-byte	No	N/A	
1,0	Yes	32-byte	No	N/A	
1,1	Yes	64-byte	No	N/A	



Once W6-4 is set by a Set Burst with Wrap command, all the following "Fast Read Quad I/O" commands will use the W6-4 setting to access the 8/16/32/64-byte section of data. Note, Status Register-2 QE bit (SR2[1]) must be set to 1 in order to use the Fast Read Quad I/O and Set Burst with Wrap commands. To exit the "Wrap Around" function and return to normal read operation, another Set Burst with Wrap command should be issued to set W4 = 1. The default value of W4 upon power on is 1.

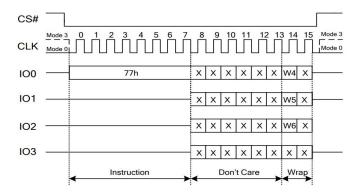


Figure 24 Set Burst with Wrap Instruction

Reset Commands

Software controlled Reset commands restore the device to its initial power up state, by reloading volatile registers from non-volatile default values. If a software reset is initiated during a Erase, Program or Writing Register operation the data in that Sector, Page or Register is not stable, the operation that was interrupted needs to be initiated again. Once the Reset instruction is accepted, any on-going internal operations will be terminated and the device will return to its default power-on state and lose all the current volatile settings, such as Volatile Status Register bits, Write Enable Latch (WEL) status, Program/Erase Suspend status, Read parameter setting (P7-P0) and Wrap Bit setting (W6-W4).

When the device is in Deep Power-Down mode, the software reset command is ignored and has no effect. To reset the device send the Release Power down command (ABh) and after time duration of t_{RES} the device will resume normal operation and the software reset command will be accepted.

Data corruption may happen if there is an on-going or suspended internal Erase or Program operation when Reset command sequence is accepted by the device. It is recommended to check the WIP bit and the SUS1/SUS2 bit in Status Register before issuing the Reset command sequence.

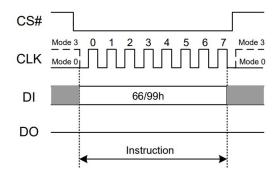


Figure 25 Software Reset Instruction



Software Reset Enable (66h)

The Reset Enable (66h) command is required immediately before a software reset command (99h) such that a software reset is a sequence of the two commands. Any command other than Reset (99h) following the Reset Enable (66h) command, will clear the reset enable condition and prevent a later Reset (99h) command from being recognized.

Software Reset (99h)

The Reset (99h) command immediately following a Reset Enable (66h) command, initiates the software reset process. Any command other than Reset (99h) following the Reset Enable (66h) command, will clear the reset enable condition and prevent a later Reset (99h) command from being recognized.

ID and Security Commands

Deep Power-down (DP) (B9h)

Although the standby current during normal operation is relatively low, standby current can be further reduced with the Power-down instruction. The lower power consumption makes the Power-down instruction especially useful for battery powered applications (See ICC1 and ICC2 in AC Characteristics). The instruction is initiated by driving the CS# pin low and shifting the instruction code "B9h" as shown in Figure 26.

The CS# pin must be driven high after the eighth bit has been latched. If this is not done, the Powerdown instruction will not be executed. After CS# is driven high, the power-down state will enter within the time duration of t_{DP} (See AC Characteristics). While in the power-down state only the Release from Power-down / Device ID instruction, which restores the device to normal operation, will be recognized. All other instructions are ignored. This includes the Read Status Register instruction, which is always available during normal operation. Ignoring all but one instruction makes the Power Down state a useful condition for securing maximum write protection. The device always powers-up in the normal operation with the standby current of ICC1.

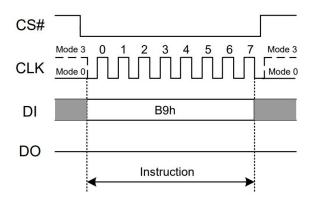


Figure 26 Deep Power-down Instruction



Release Power-down / Device ID (ABh)

The Release from Power-down / Device ID instruction is a multi-purpose instruction. It can be used to release the device from the power-down state, obtain the devices electronic identification (ID) number or both.

To release the device from the power-down state, the instruction is issued by driving the CS# pin low, shifting the instruction code "ABh" and driving CS# high as shown in Figure 27. After the time duration of tRES1 (See AC Characteristics) the device will resume normal operation and other instructions will be accepted. The CS# pin must remain high during the tRES1 time duration.

When used only to obtain the Device ID during the non-power-down state, the instruction is initiated by driving the CS# pin low and shifting the instruction code "ABh" followed by 3-dummy bytes. The Device ID bits will then be shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 28. The Device ID value for the HG25Q16B is listed in Manufacturer and Device Identification table. The Device ID can be read continuously. The instruction is completed by driving CS# high.

When used to release the device from the power-down state and obtain the Device ID, the instruction is the same as previously described, and shown in Figure 28, except that after CS# is driven high it must remain high for a time duration of t_{RES2} (See AC Characteristics). After this time duration the device will resume normal operation and other instructions will be accepted. If the Release from Power-down / Device ID instruction is issued within Erase, Program or Write cycle (when BUSY equals 1), the instruction is ignored and will not have any effects on the current cycle.

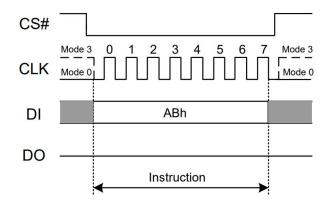


Figure 27 Release Power-down Instruction

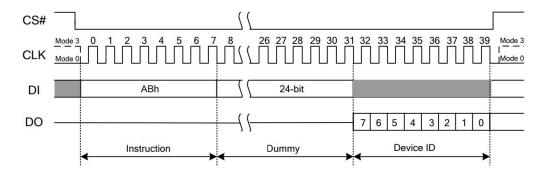


Figure 28 Release Power-down / Device ID



Read Manufacturer / Device ID (90h)

The Read Manufacturer/Device ID instruction is an alternative to the Release from Power-down/Device ID instruction that provides both the JEDEC assigned manufacturer ID and the specific device ID.

The Read Manufacturer/Device ID instruction is very similar to the Release from Power-down / Device ID instruction. The instruction is initiated by driving the CS# pin low and shifting the instruction code "90h" followed by a 24-bit address (A23-A0) of 000000h. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 29. If the 24-bit address is initially set to 000001h the Device ID will be read first and then followed by the Manufacturer ID. The Manufacturer and Device IDs can be read continuously, alternating from one to the other. The command is completed by driving CS# high.

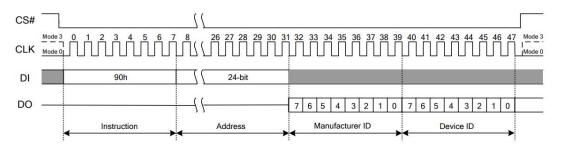


Figure 29 Read Manufacturer/Device ID

Read Identification (RDID) (9Fh)

For compatibility reasons, the HG25Q16B provides several instructions to electronically determine the identity of the device. The Read JEDEC ID instruction is compatible with the JEDEC standard for SPI compatible serial memories that was adopted in 2003.

The instruction is initiated by driving the CS# pin low and shifting the instruction code "9Fh". The JEDEC assigned Manufacturer ID byte and two Device ID bytes, Memory Type (ID15-ID8) and Capacity (ID7-ID0) are then shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 30. For memory type and capacity values, refer to Manufacturer and Device Identification table.

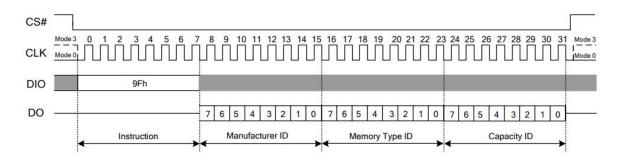


Figure 30 Read JEDEC ID



Read SFDP Register (5Ah)

The Read SFDP command is initiated by driving the CS# pin low and shifting the instruction code "5Ah" followed by a 24-bit address (A23-A0) into the DI pin. Eight "dummy" clocks are also required before the SFDP register contents are shifted out on the falling edge of the 40th CLK with most significant bit (MSB) first as shown in Figure 31.

Note: A23-A8 = 0; A7-A0 are used to define the starting byte address for the 256-byte SFDP Register.

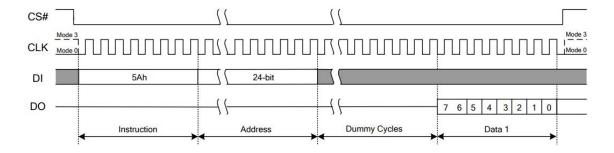


Figure 31 Read SFDP Register Instruction

Erase Security Registers (44h)

The HG25Q16B offers three 256-byte Security Registers which can be erased and programmed individually. These registers may be used by system manufacturers to store security and other important information separately from the main memory array.

The Erase Security Register command is similar to the Sector Erase command. A Write Enable command must be executed before the device will accept the Erase Security Register Command (Status Register bit WEL must equal to 1). The command is initiated by driving the CS# pin low and shifting the instruction code "44h" followed by a 24-bit address (A23-A0) to erase one of the security registers.

Address	A23-16	A15-8	A7-0
Security Register-1	00h	10h	xxh
Security Register-2	00h	20h	xxh
Security Register-3	00h	30h	xxh

Note:

1. Addresses outside the ranges in the table have undefined results

The Erase Security Register command sequence is shown in Figure 32. The CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the command will not be executed. After CS# is driven high, the self-timed Erase Security Register operation will commence for a time duration of t_{SE} (see Section 8.5, AC Electrical Characteristics). While the Erase Security Register cycle is in progress, the Read Status Register command may still be accessed for checking the status of the BUSY bit. The BUSY bit is a 1 during the erase cycle and becomes a 0 when the cycle is finished and the device is ready to accept other commands again. After the Erase Security Register cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Security Register Lock Bits (LB[3:1]) in the Status Register-2 can be used to OTP protect the security registers. Once a lock bit is set to 1, the corresponding security register will be permanently locked, and an Erase Security Register command to that register will be ignored.



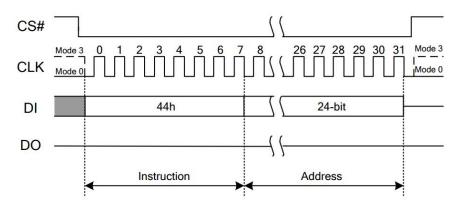


Figure 32 Erase Security Registers Instruction

Program Security Registers (42h)

The Program Security Register command is similar to the Page Program command. It allows from one byte to 256 bytes of security register data to be programmed at previously erased (FFh) memory locations. A Write Enable command must be executed before the device will accept the Program Security Register Command (Status Register bit WEL= 1). The command is initiated by driving the CS# pin low then shifting the instruction code "42h" followed by a 24-bit address (A23-A0) and at least one data byte, into the DI pin. The CS# pin must be held low for the entire length of the command while data is being sent to the device.

Address	A23-16	A15-8	A7-0
Security Register-1	00h	10h	Byte Address
Security Register-2	00h	20h	Byte Address
Security Register-3	00h	30h	Byte Address

Note: 1. Addresses outside the ranges in the table have undefined results.

The Program Security Register command sequence is shown in Figure 33. The Security Register Lock Bits (LB3:1) in the Status Register-2 can be used to OTP protect the security registers. Once a lock bit is set to 1, the corresponding security register will be permanently locked, and a Program Security Register command to that register will be ignored.

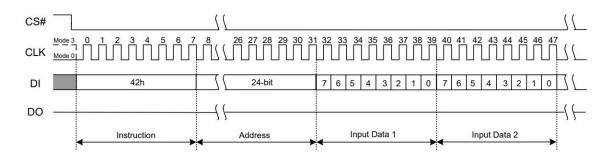


Figure 33 Program Security Registers Instruction



Read Security Registers (48h)

The Read Security Register command is similar to the Fast Read command and allows one or more data bytes to be sequentially read from one of the three security registers. The command is initiated by driving the CS# pin low and then shifting the instruction code "48h" followed by a 24-bit address (A23-A0) and eight "dummy" clocks into the DI pin. The code and address bits are latched on the rising edge of the CLK pin. After the address is received, and following the eight dummy cycles, the data byte of the addressed memory location will be shifted out on the DO pin at the falling edge of CLK with most significant bit (MSB) first. Locations with address bits A23-A16 not equal to zero, have undefined data. The byte address is automatically incremented to the next byte address after each byte of data is shifted out. Once the byte address reaches the last byte of the register (FFh), it will reset to the first byte of the register (00h) and continue to increase. The command is completed by driving CS# high. The Read Security Register command sequence is shown in Figure 34. If a Read Security Register command is ignored and will not have any effects on the current cycle. The Read Security Register command allows clock rates from DC to a maximum of FR (see Section 8.5, AC Electrical Characteristics).

Address	A23-16	A15-8	A7-0
Security Register-1	00h	10h	Byte Address
Security Register-2	00h	20h	Byte Address
Security Register-3	00h	30h	Byte Address

Note: 1. Addresses outside the ranges in the table have undefined results.

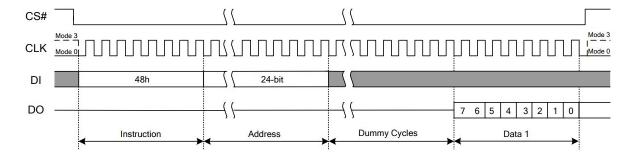


Figure 34 Read Security Registers Instruction



Read Unique ID Number (4Bh)

The Read Unique ID Number instruction accesses a factory-set read-only 128-bit number which is unique to each HG25Q16B device. The ID number can be used in conjunction with user software methods to help prevent copying or cloning of a system. The Read Unique ID instruction is initiated by driving the CS# pin low and shifting the instruction code "4Bh" followed by 24-bit address (000000H) and one byte dummy clocks. After that, the 128-bit ID is shifted out on the falling edge of CLK as shown in Figure 35.

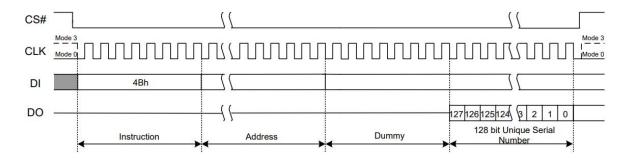


Figure 35 Read unique ID Number Instruction



ELECTRICAL CHARACTERISTIC

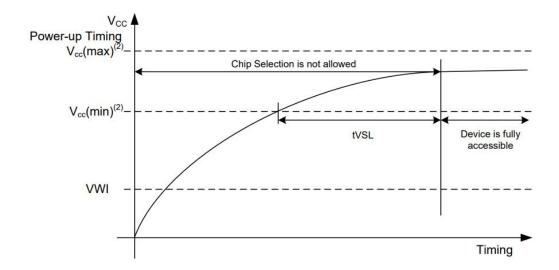


Figure 36 Power-up Timing

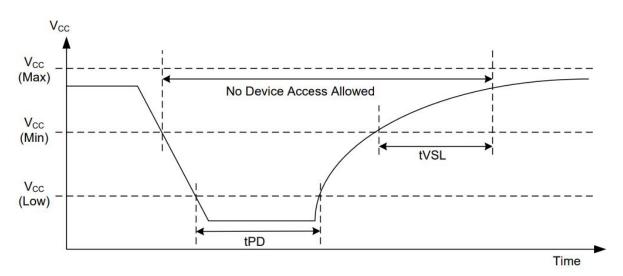


Figure 37 Power-Down and Voltage Drop

Table 21 Power-up Timing

PARAMETER	SYMBOL	TY		
PARAMETER	STWIBOL	MIN	MAX	UNIT
Vcc(minimum operation voltage)	Vcc(min)	2.7	-	V
Vcc(low voltage for initialization to occur)	Vcc(low)	-	0.7	V
Vcc (min) to CS# Low	tVSL ⁽¹⁾	500	-	μs
The minimum duration for ensuring initialization will occur	tPD	300	-	μs
Write Inhibit Threshold Voltage	VWI ⁽¹⁾	1	2.2	V

Notes:

- (1) The parameters are characterized only.
- (2) VCC (max.) is 3.6V and VCC (min.) is 2.7V.



Absolute Maximum Ratings

Stresses above the values mentioned as following may cause permanent damage to the device. These values are for a stress rating only and do not imply that the device should be operated at conditions up to or above these values

Table 22⁽¹⁾ Absolute Maximum Rating.

PARAMETERS(2)	SYMBOL	CONDITIONS	RANGE	UNIT	
Supply Voltage	VCC		-0.6 to +4.2	V	
Voltage applied on any pin	VIO	Relative to Ground	-0.6 to VCC+0.4	V	
Transient Voltage on any Pin	VIOT	<20ns Transient Relative to Ground	-2.0 to VCC+2.0	V	
Storage Temperature	TSTG		-65 to +150	$^{\circ}$ C	
Lead Temperature	TLEAD		245	$^{\circ}$	
Electrostatic Discharge Voltage	VESD	Human Body Model(4)	-2000 to +2000	V	

Notes:

- (1) Specification for HG25Q16B is preliminary. See preliminary designation at the end of this document.
- (2) This device has been designed and tested for the specified operation ranges. Proper operation outside these levels is not guaranteed. Exposure to absolute maximum ratings may affect device reliability. Exposure beyond absolute maximum ratings may cause permanent damage.
- (3) Compatible to JEDEC Standard J-STD-20C for small body Sn-Pb or Pb-free (Green) assembly and the European directive on restrictions on hazardous substances (RoHS) 2002/95/EU.
- (4) JEDEC Std. JESD22-A114A (C1=100 pF, R1=1500 ohms, R2=500 ohms).

Recommended Operating Ranges

Table 23 Recommended Operating Ranges

PARAMETER	CVMPOL	CONDITIONS	S	PEC	UNIT	
PARAMETER	SYMBOL CONDITIONS		MIN	MAX	UNIT	
Supply Voltage	VCC(1)	FR=133MHz,fR=104MHz	2.7	3.6	V	
Ambient Temperature, Operating	TA	Industrial	-40	125	${\mathbb C}$	

Notes:

(1) Recommended Operating Ranges define those limits between which the functionality of the device is guaranteed.



DC Characteristics

Table 24a DC Characteristics

 $(T = -40^{\circ}C \sim 105^{\circ}C, VCC = 2.7 \sim 3.6V)$

0.44501	D.D.W.	COMPITIONS	SPEC			112117	
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT	
CIN ⁽¹⁾	Input Capacitance	VIN = 0V ⁽²⁾			6	pF	
COUT ⁽¹⁾	Output Capacitance	VOUT = 0V ⁽²⁾			8	pF	
ILI	Input Leakage				±2	uA	
ILO	I/O Leakage				±2	uA	
ICC1	Standby Current	CS# = V _{CC} , VIN= GND or V _{CC}		10	20	uA	
ICC2	Power-down Current	$CS\# = V_{CC},$ VIN= GND or V_{CC}		1	5	uA	
ICC3	Current *1 I/O Read 1MHz ⁽²⁾	C = 0.1 V _{CC} / 0.9 V _{CC} DO = Open		1	2	mA	
ICC3	Current *1 I/O Read 33MHz ⁽²⁾	C = 0.1 V _{CC} / 0.9 V _{CC} DO = Open		1.8	3	mA	
ICC3	Current *1 I/O Read 66MHz ⁽²⁾	C = 0.1 V _{CC} / 0.9 V _{CC} DO = Open		2.7	5	mA	
ICC3	Current *4 Output Read 50MHz ⁽²⁾	C = 0.1 V _{CC} / 0.9 V _{CC} IOs = Open		3	6	mA	
ICC3	Current *4 Output Read 83MHz ⁽²⁾	C = 0.1 V _{CC} / 0.9 V _{CC} IOs = Open		4.5	9	mA	
ICC3	Current *4 Output Read 104MHz ⁽²⁾	C = 0.1 V _{CC} / 0.9 V _{CC} IOs = Open		5	10	mA	
ICC4	Current Page Program	CS# = V _{CC}		3	8	mA	
ICC5	Current Write Status Register	CS# = V _{CC}		2	8	mA	
ICC6	Current Sector/Block Erase	CS# = V _{CC}		3	8	mA	
ICC7	Current Chip Erase	CS# = V _{CC}		3	8	mA	
VIL	Input Low Voltage				V _{CC} ×0.2	V	
VIH	Input High Voltage		V _{CC} ×0.7			V	
VOL	Output Low Voltage	IOL = 100 uA			0.2	V	
VOH	Output High Voltage	IOH = - 100 uA	V _{CC} - 0.2			V	

Notes:

- (1) Tested on sample basis and specified through design and characterization data. TA=25° C, VCC=3V.
- (2) Checker Board Pattern.



Table 24b DC Characteristics

 $(T = -40^{\circ}C \sim 125^{\circ}C, VCC = 2.7 \sim 3.6V)$

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
CIN ⁽¹⁾	Input Capacitance	VIN = 0V ⁽²⁾			6	pF
COUT ⁽¹⁾	Output Capacitance	VOUT = 0V(2)			8	pF
ILI	Input Leakage				±2	uA
ILO	I/O Leakage				±2	uA
ICC1	Standby Current	$CS\# = V_{CC},$ VIN= GND or V_{CC}		10	30	uA
ICC2	Power-down Current	CS# = V _{CC} , VIN= GND or V _{CC}		1	8	uA
ICC3	Current *1 I/O Read 1MHz ⁽²⁾	C = 0.1 V _{cc} / 0.9 V _{cc} DO = Open		1	2	mA
ICC3	Current *1 I/O Read 33MHz ⁽²⁾	$C = 0.1 V_{CC} / 0.9 V_{CC}$ DO = Open		1.8	3	mA
ICC3	Current *1 I/O Read 66MHz ⁽²⁾	$C = 0.1 V_{CC} / 0.9 V_{CC}$ DO = Open		2.7	5	mA
ICC3	Current *4 Output Read 50MHz ⁽²⁾		·	3 6	6	mA
ICC3	Current *4 Output Read 83MHz ⁽²⁾	C = 0.1 V _{CC} / 0.9 V _{CC} IOs = Open		4.5	9	mA
ICC3	Current *4 Output Read	C = 0.1 V _{CC} / 0.9 V _{CC} IOs = Open		5	10	mA
ICC4	Current Page Program	CS# = Vcc		3	8	mA
ICC5	Current Write Status Register	CS# = V _{CC}		2	8	mA
ICC6	Current Sector/BlockErase	CS# = V _{CC}		3	8	mA
ICC7	Current Chip Erase	CS# = V _{CC}		3	8	mA
VIL	Input Low Voltage				V _{CC} ×0.2	٧
VIH	Input High Voltage		V _{CC} ×0.7			٧
VOL	Output Low Voltage	IOL = 100 uA			0.2	٧
VOH	Output High Voltage	IOH = - 100 uA	V _{CC} - 0.2			V

Notes:

- (1) Tested on sample basis and specified through design and characterization data. TA=25° C, VCC=3V.
- (2) Checker Board Pattern.



AC Measurement Conditions

Table 25 AC Measurement Conditions

Symbol	PARAMETER	Min.	Max.	Unit
CL	Load Capacitance		30	pF
TR, TF	Input Rise and Fall Times		5	ns
VIN	Input Pulse Voltages	0.2V _{CC} to 0.8V _{CC}		V
VtIN	Input Timing Reference Voltages	0.3V _{CC} to 0.7V _{CC}		V
VtON	Output Timing Reference Voltages	0.5 V _{CC} to 0.5 V _{CC}		V

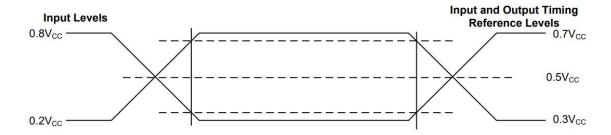


Figure 38 AC Measurement I/O Waveform



AC Electrical Characteristics

Table 26a AC Electrical Characteristics

 $(T = -40^{\circ}C \sim 105^{\circ}C, VCC = 2.7 \sim 3.6V, C_L = 30pf)$

SYMBOL	A. T	Dovementor				
STWBUL	ALT	Parameter	MIN	TYP	MAX	UNIT
F _{R1}	f _{C1}	Clock frequency for BBh or EBh instructions with DC=1	D.C.		133	MHz
F _{R2}	f _{C2}	Clock frequency for BBh or EBh instructions with DC=0	D.C.		104	MHz
F _{R3}	f _{C3}	Clock frequency for 0Bh, 3Bh or 6Bh instructions	D.C.		133	MHz
f_{R}		Clock frequency for Read Data instruction (03h)	D.C.		104	MHz
t _{CLH} , t _{CLL} ⁽¹⁾		Clock High, Low Time for all instructions	45%(1/f _c)			ns
tC _{LCH} ⁽²⁾		Clock Rise Time peak to peak	0.2			V/ns
tC _{HCL} ⁽²⁾		Clock Fall Time peak to peak	0.2			V/ns
tS _{LCH}	tcss	CS# Active Setup Time relative to CLK	5			ns
t _{CHSL}		CS# Not Active Hold Time relative to CLK	5			ns
t _{DVCH}	t _{DSU}	Data In Setup Time	2			ns
t _{CHDX}	t _{DH}	Data In Hold Time	2			ns
tchsh		CS# Active Hold Time relative to CLK	5			ns
tshch		CS# Not Active Setup Time relative to CLK	5			ns
t _{SHSL}	tcsH	CS# Deselect Time (Read / Write)	20			ns
t _{SHQZ} (2)	t _{DIS}	Output Disable Time			6	ns
tclqv	t _V	Clock Low to Output Valid 2.7V- 3.6V			6	ns
t _{CLQX}	t _{HO}	Output Hold Time	2			ns
t _{HLCH}		HOLD# Active Setup Time relative to CLK	5			ns
t _{СННН}		HOLD# Active Hold Time relative to CLK	5			ns
t _{HHCH}		HOLD# Not Active Setup Time relative to CLK	5			ns
t _{CHHL}		HOLD# Not Active Hold Time relative to CLK	5			ns
t _{HHQX}	t _{LZ} (2)	HOLD# to Output Low-Z			6	ns
t _{HLQZ}	t _{HZ} (2)	HOLD# to Output High-Z			6	ns
t _{WHSL} (3)		Write Protect Setup Time Before CS# Low	20			ns
t _{SHWL} (3)		Write Protect Hold Time After CS# High	100			ns
t _{DP} ⁽²⁾		CS# High to Power-down Mode			3	μs
t _{R ES} (2)		CS# High to Standby Mode without Electronic Signature Read			8	μs
t _{RES2} (2)		CS# High to Standby Mode with Electronic Signature Read			6	μs
$t_{su s}^{(2)}$		CS# High to next Command after Suspend			20	μs
t _{RS1}		Latency between Resume and next Suspend during Sector Erase	10			ms
t _{RS2}		Latency between Resume and next Suspend during Block Erase	50			ms
t _W		Write Status Register Time		2	20	ms
t _{PP}		Page Program Time		0.25	5	ms
t _{SE}		Sector Erase Time (4KB)		45	300	ms
t _{BE1}		Block Erase Time (32KB)		0.12	1.5	s
t _{BE2}		Block Erase Time (64KB)		0.15	2	s
t _{CE}		Chip Erase Time		3	30	s
t _{RST} ⁽²⁾		CE# High to next Instruction after Reset (Except From Erase)			30	us
t _{RST_E} (2)		CE# High to next Instruction after Reset (From Erase)			50	us

Notes:

- (1) Clock high + Clock low must be less than or equal to $1/f_{\mbox{\scriptsize C}}$.
- (2) Value guaranteed by design and/or characterization, not 100% tested in production.
- (3) Only applicable as a constraint for a Write Status Register instruction when Sector Protect Bit is set to 1.



Table 26b AC Electrical Characteristics

 $(T = -40^{\circ}C \sim 125^{\circ}C, VCC = 2.7 \sim 3.6V, CL = 30pf)$

CVMDOL	ALT	Parameter		LINUT		
SYMBOL	ALI	Parameter	MIN	TYP	MAX	UNIT
F _{R1}	f _{C1}	Clock frequency for BBh or EBh instructions with DC=1	D.C.		133	MHz
F _{R2}	f _{C2}	Clock frequency for BBh or EBh instructions with DC=0	D.C.		104	MHz
F _{R3}	f _{C3}	Clock frequency for 0Bh, 3Bh or 6Bh instructions	D.C.		133	MHz
f _R		Clock frequency for Read Data instruction (03h)	D.C.		104	MHz
t _{CLH} ,t _{CLL} (1)		Clock High, Low Time for all instructions	45%(1/f _c)			ns
t _{CLCH} ⁽²⁾		Clock Rise Time peak to peak	0.2			V/ns
t _{CHCL} ⁽²⁾		Clock Fall Time peak to peak	0.2			V/ns
t _{SLCH}	t _{CSS}	CS# Active Setup Time relative to CLK	5			ns
t _{CHSL}		CS# Not Active Hold Time relative to CLK	5			ns
t _{DVCH}	t _{DSU}	Data In Setup Time	2			ns
t _{CHDX}	t _{DH}	Data In Hold Time	2			ns
tchsh		CS# Active Hold Time relative to CLK	5			ns
tsнсн		CS# Not Active Setup Time relative to CLK	5			ns
t _{SHSL}	tсsн	CS# Deselect Time (Read / Write)	20			ns
t _{SHQZ} (2)	t _{DIS}	Output Disable Time			6	ns
t _{CLQV}	t _V	Clock Low to Output Valid 2.7V- 3.6V			6	ns
tcLQX	t _{HO}	Output Hold Time	2			ns
t _{HLCH}		HOLD# Active Setup Time relative to CLK	5			ns
tсннн		HOLD# Active Hold Time relative to CLK	5			ns
tннсн		HOLD# Not Active Setup Time relative to CLK	5			ns
tchhl		HOLD# Not Active Hold Time relative to CLK	5			ns
tннqх	t _{LZ} (2)	HOLD# to Output Low-Z			6	ns
t _{HLQZ}	t _{HZ} (2)	HOLD# to Output High-Z			6	ns
twhsL(3)		Write Protect Setup Time Before CS# Low	20			ns
t _{SHWL} (3)		Write Protect Hold Time After CS# High	100			ns
t _{DP} (2)		CS# High to Power-down Mode			3	μs
t _{R ES} (2)		CS# High to Standby Mode without Electronic SignatureRead			8	μs
t _{RES 2} (2)		CS# High to Standby Mode with Electronic SignatureRead			6	μs
t _{su s} (2)		CS# High to next Command after Suspend			20	μs
tRS1		Latency between Resume and next Suspend duringSector Erase	10			ms
t _{RS2}		Latency between Resume and next Suspend during BlockErase	50			ms
tw		Write Status Register Time		2	25	ms
t _{PP}		Page Program Time		0.25	8	ms
t _{SE}		Sector Erase Time (4KB)		45	450	ms
t _{BE1}		Block Erase Time (32KB)		0.12	2	s
t _{BE2}		Block Erase Time (64KB)		0.15	2.5	s
t _{CE}		Chip Erase Time		3	35	s
t _{RST} ⁽²⁾		CE# High to next Instruction after Reset (Except FromErase)			30	us
t _{RST_E} (2)		CE# High to next Instruction after Reset (From Erase)			50	us

Notes:

- (1)Clock high + Clock low must be less than or equal to 1/fc.
- (2) Value guaranteed by design and/or characterization, not 100% tested in production.
- (3)Only applicable as a constraint for a Write Status Register instruction when Sector Protect Bit is set to 1.



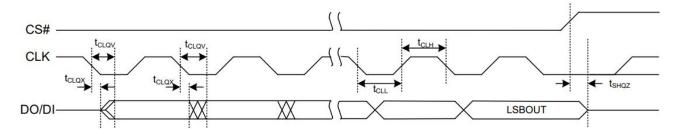


Figure 39 Serial Output Timing

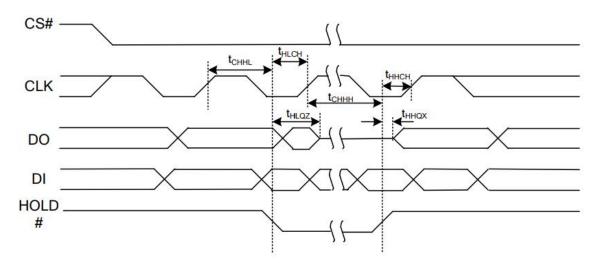


Figure 40 Hold Timing

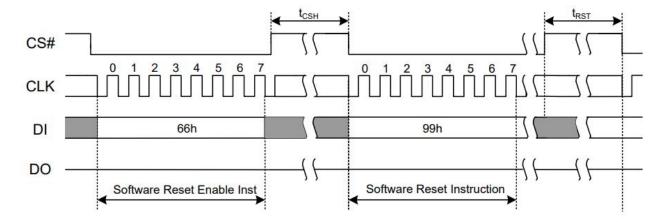
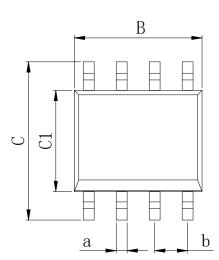


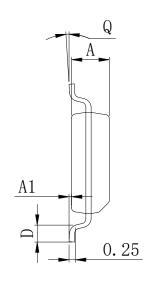
Figure 41 Software Reset Input Timing



Physical Dimensions

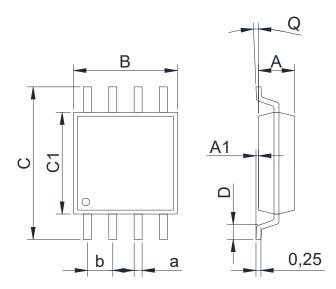
SOP-8 (150mil)





Dimensions In Millimeters(SOP-8)									
Symbol:	Α	A1	В	С	C1	D	Q	а	b
Min:	1.35	0.05	4.90	5.80	3.80	0.40	0°	0.35	1.27 BSC
Max:	1.55	0.20	5.10	6.20	4.00	0.80	8°	0.45	1.21 000

SOP-8 (208MIL)

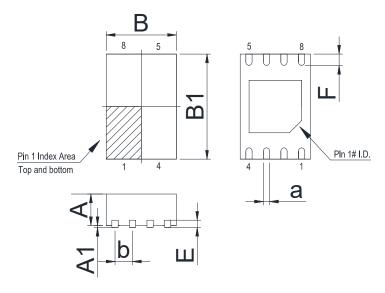


Dimensions In Millimeters(SOP-8)										
Symbol:	Α	A1	В	С	C1	D	Q	а	b	
Min:	1.70	0.05	5.18	7.70	5.18	0.5	0°	0.35	4 27 BCC	
Max:	1.91	0.25	5.38	8.70	5.38	0.8	8°	0.48	1.27 BSC	



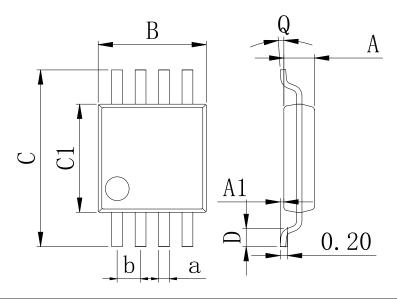
Physical Dimensions

DFN-8 2*3



Dimensions In Millimeters(DFN-8 2*3)								
Symbol:	Α	A1	В	B1	Е	F	а	b
Min:	0.85	0	1.90	2.90	0.15	0.25	0.20	0.50TYP
Max:	0.95	0.05	2.10	3.10	0.25	0.35	0.30	0.5011P

MSOP-8



Dimensions In Millimeters(MSOP-8)									
Symbol:	Α	A1	В	С	C1	D	Q	а	b
Min:	0.80	0.05	2.90	4.75	2.90	0.35	0°	0.25	- 0.65 BSC
Max:	0.90	0.20	3.10	5.05	3.10	0.75	8°	0.35	



Revision History

DATE	REVISION	PAGE
2014-1-12	New	1-63
2023-7-25	Update encapsulation type、Update Lead Temperature	1、53



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